

Introduction to particle physics: experimental part

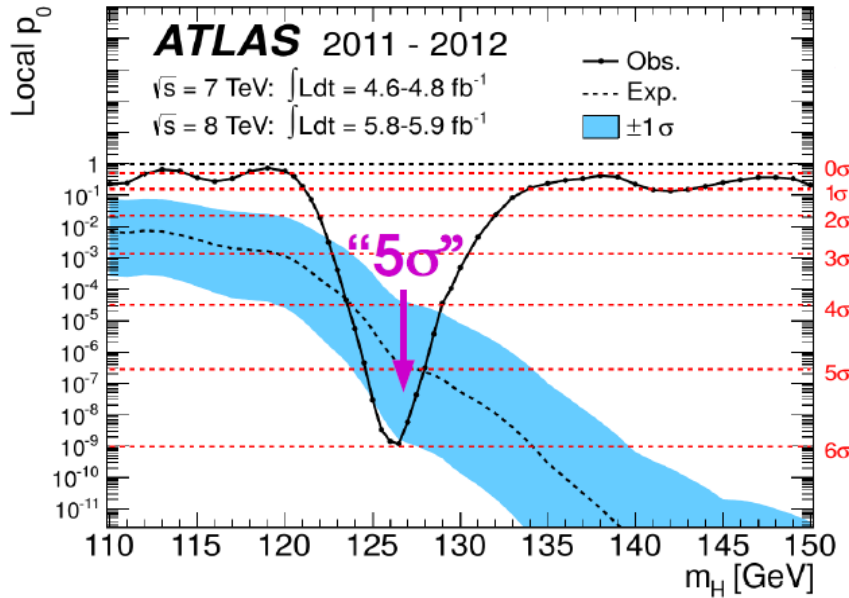
- ❑ **Statistical basics for physics**
 - **Random processes**
 - **Probability distributions**
- ❑ **Describing physics measurements**
 - **Binned and unbinned data**
 - **Model parameters**

Slides extracted from N. Berger lectures at CERN Summer School 2019

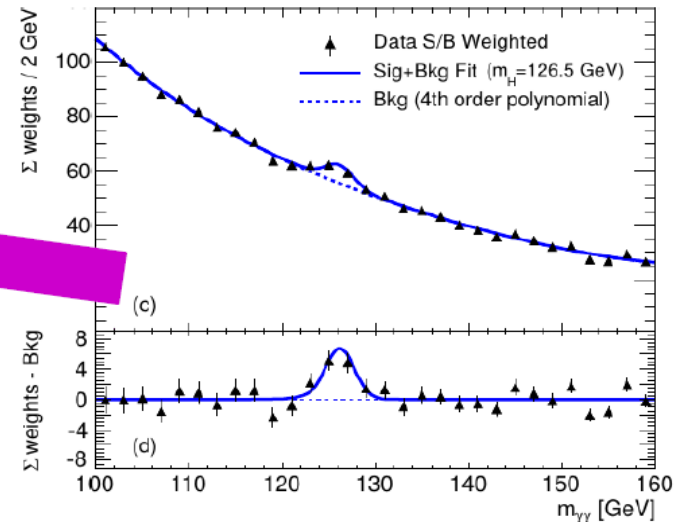
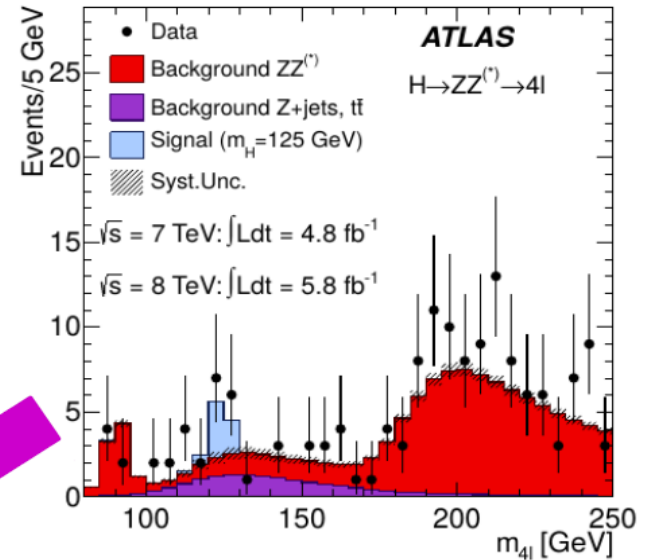
Introducion

Statistical methods play a critical role in many areas of physics

Higgs discovery : **"We have 5 σ " !**

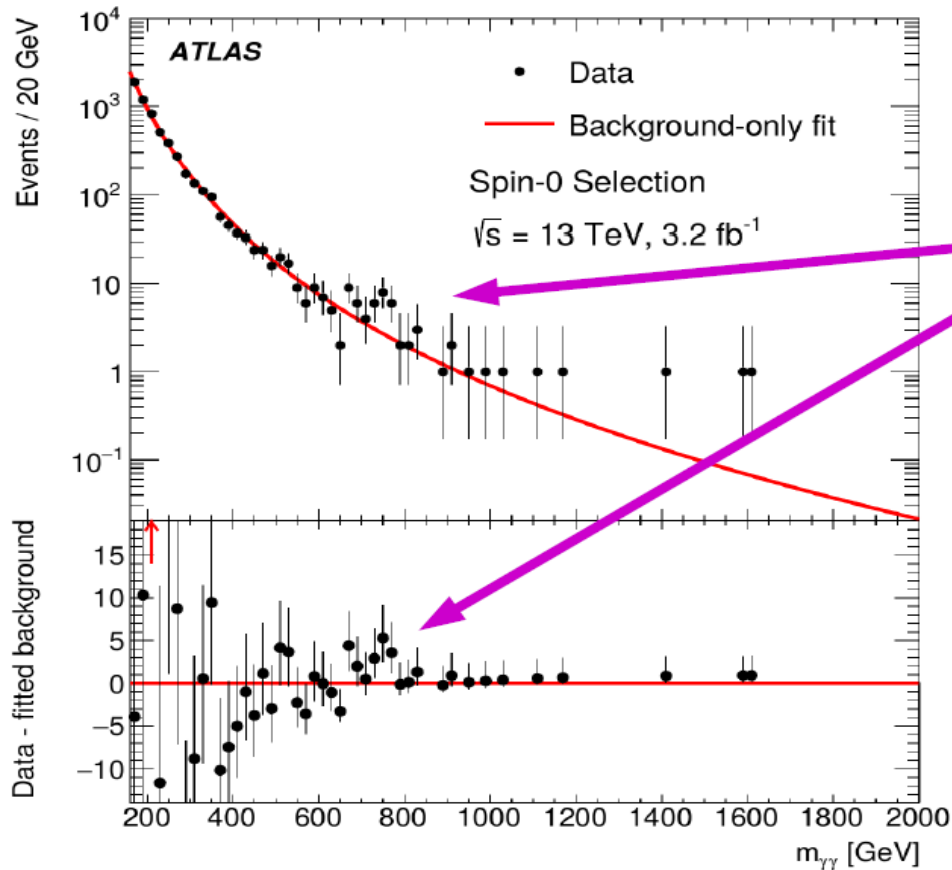


Phys. Lett. B 716 (2012) 1-29



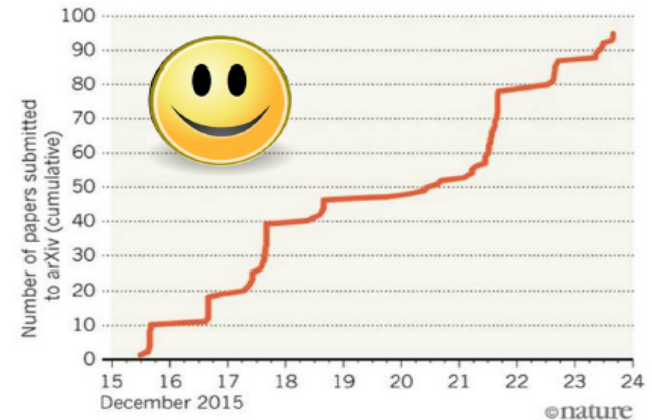
Introduction

Sometimes difficult to distinguish a bona fide discovery from a **background fluctuation**...



New Physics ?

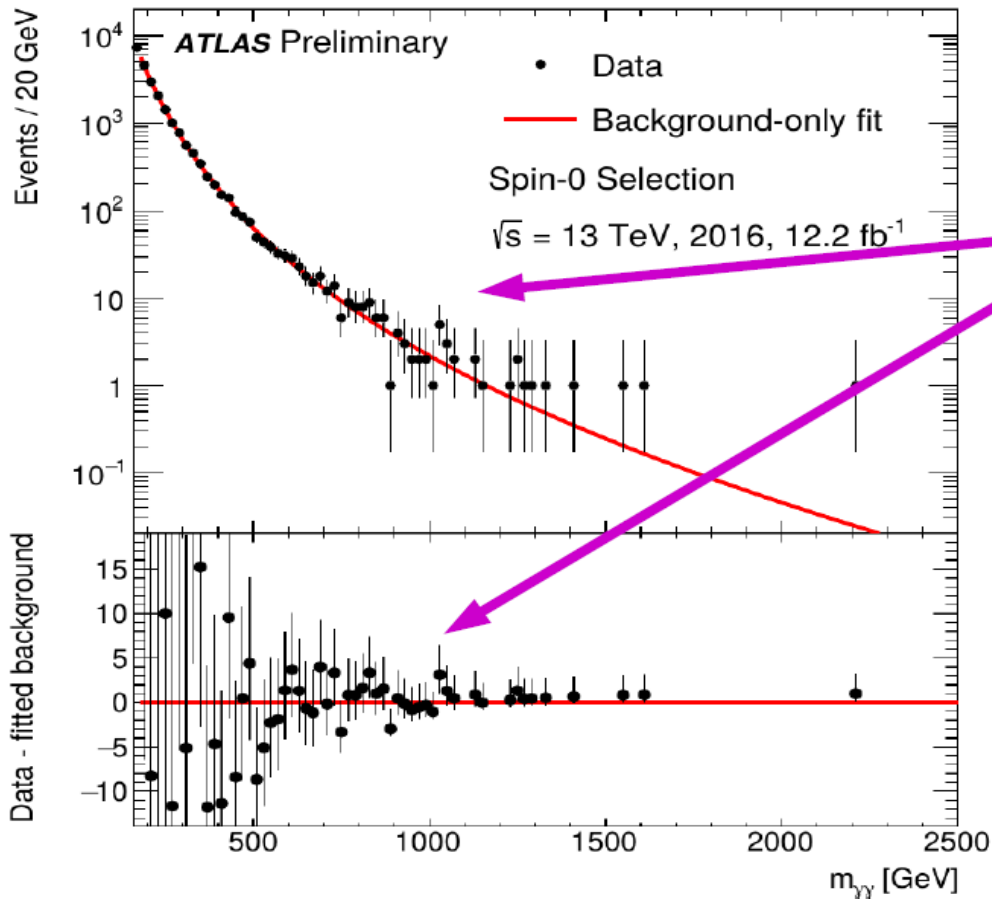
3.9 σ ? 2.1 σ ?



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Introduction

Sometimes difficult to distinguish a bona fide discovery from a **background fluctuation**...



A few months later...

~~New Physics ?~~

~~$3.9\sigma ? 2.1\sigma ?$~~

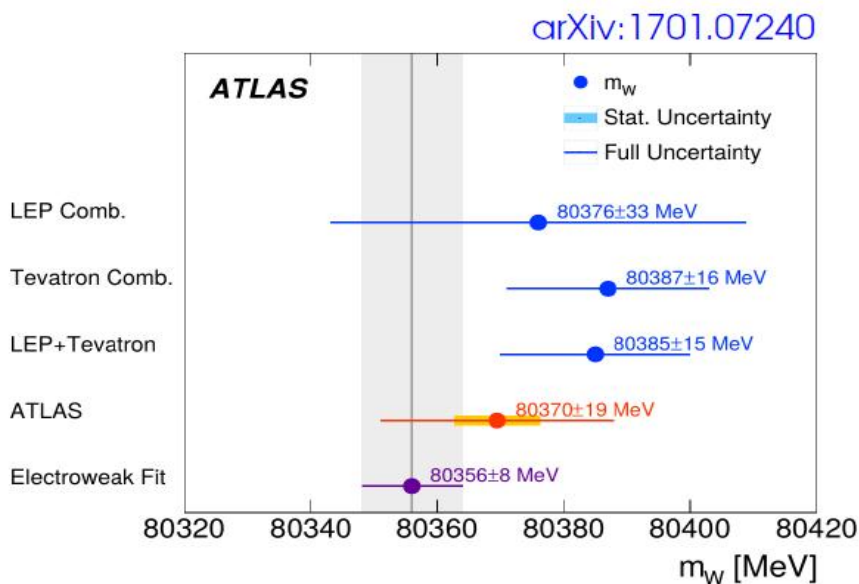


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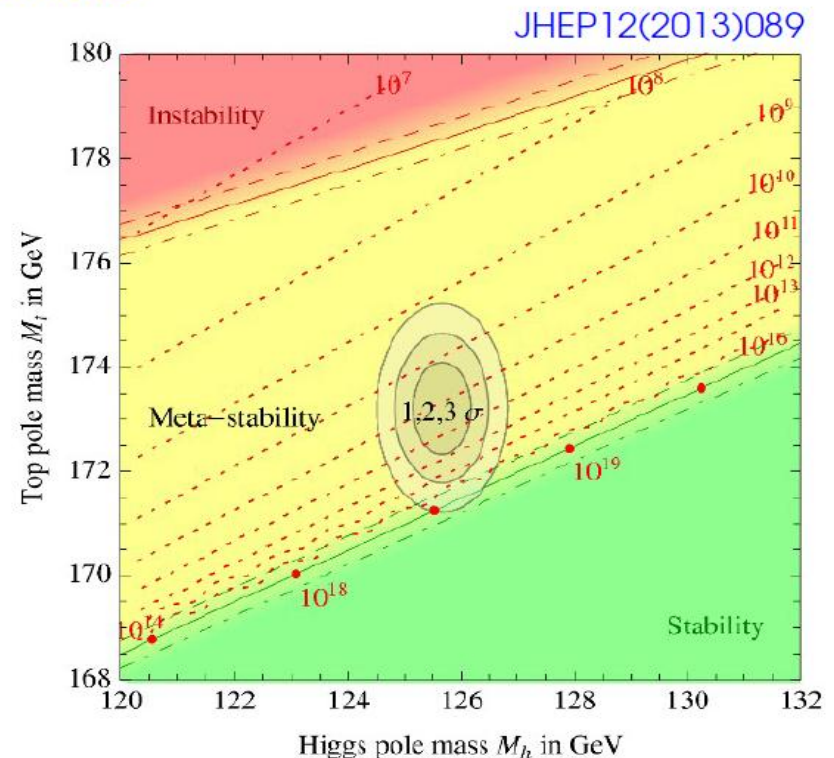
Uncertainties

Many important questions answered by **precision measurements**, especially if no new peaks found at high mass...

Key point = determination of **uncertainties**

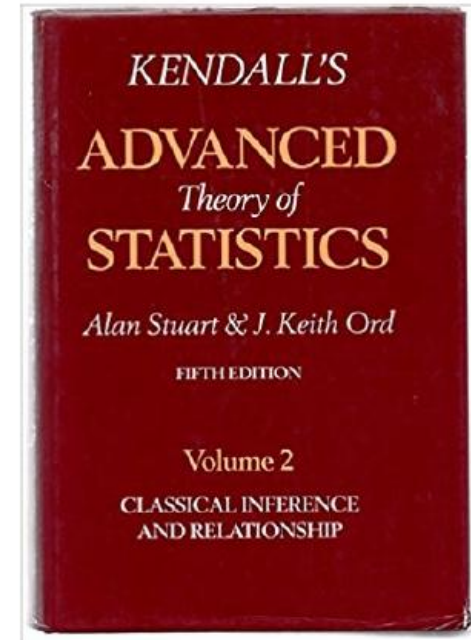
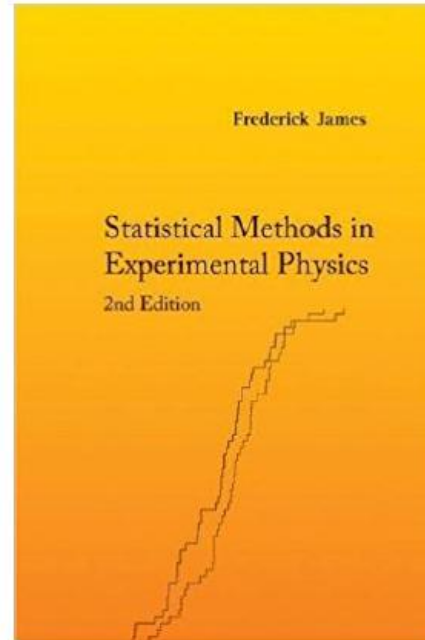
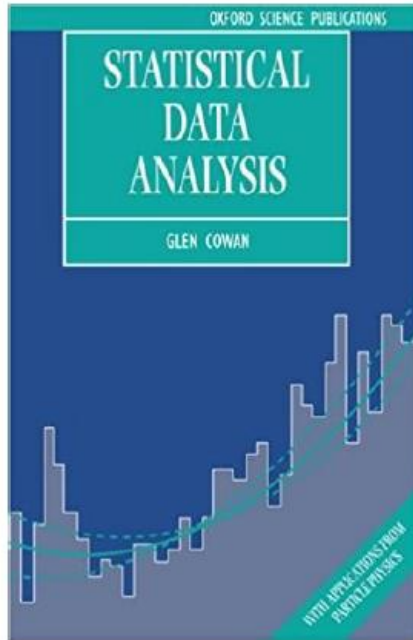


Consistency of the SM...



... or the fate of the universe

Books and Courses



Some other courses available online:

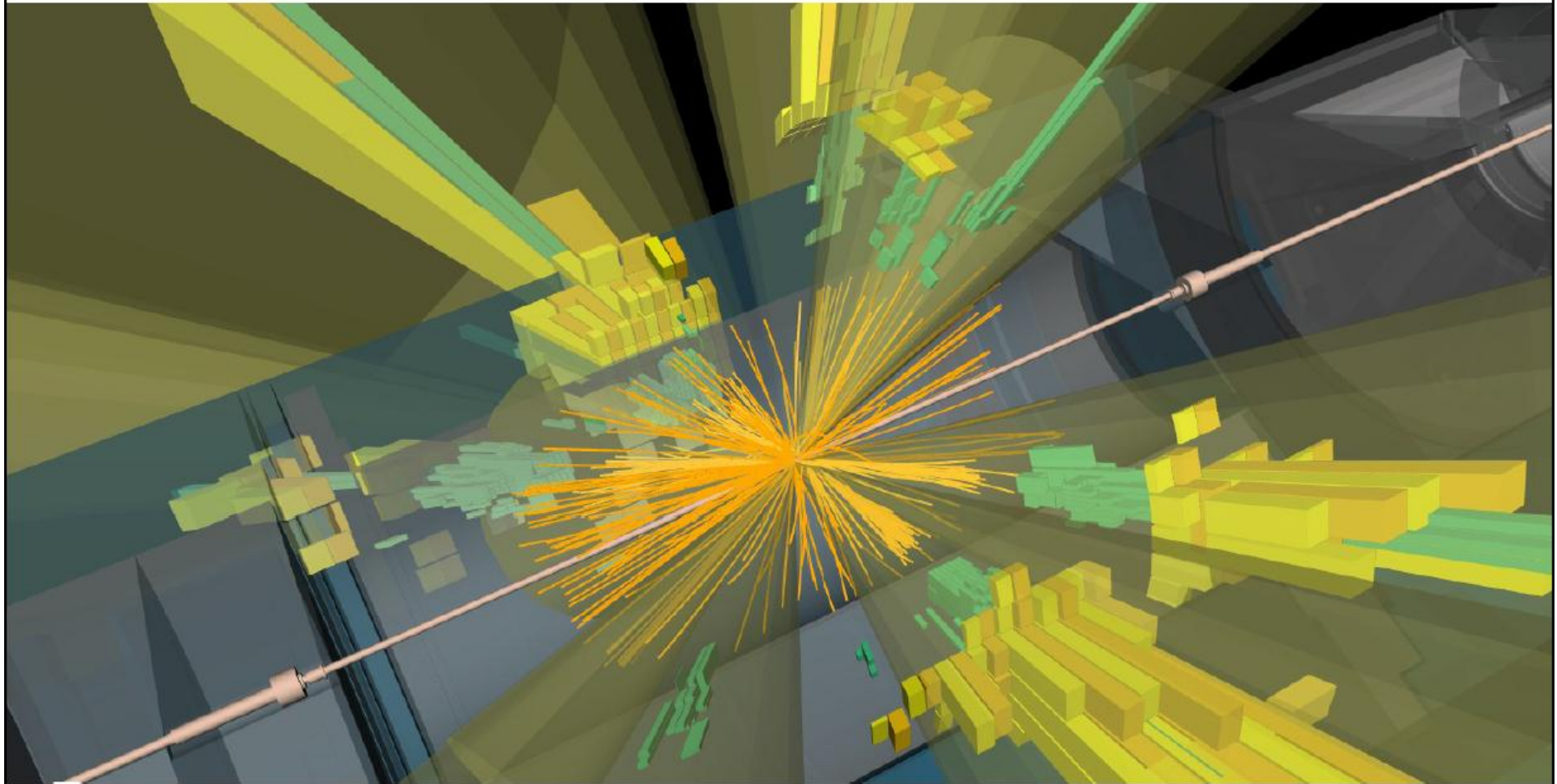
Glen Cowan's [Cours d'Hiver](#) and [2010 CERN Academic Training lectures](#)

Kyle Cranmer's [CERN Academic Training lectures](#)

Louis Lyons' and Lorenzo Moneta's [CERN Academic Training Lectures](#)

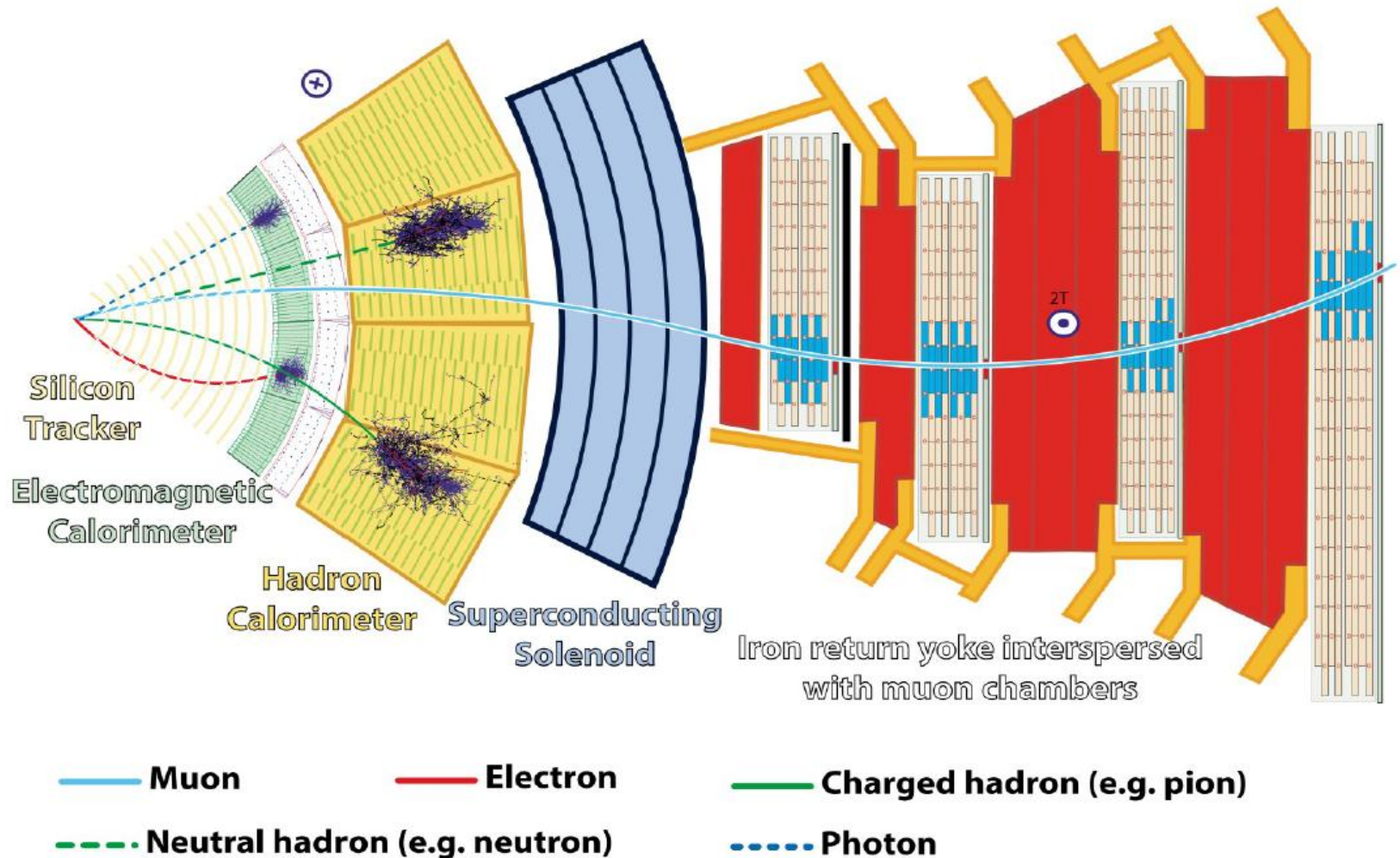
Randomness in High Energy Physics

Experimental data is produced by incredibly complex processes



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Randomness in High Energy Physics

Experimental data is produced by incredibly complex processes

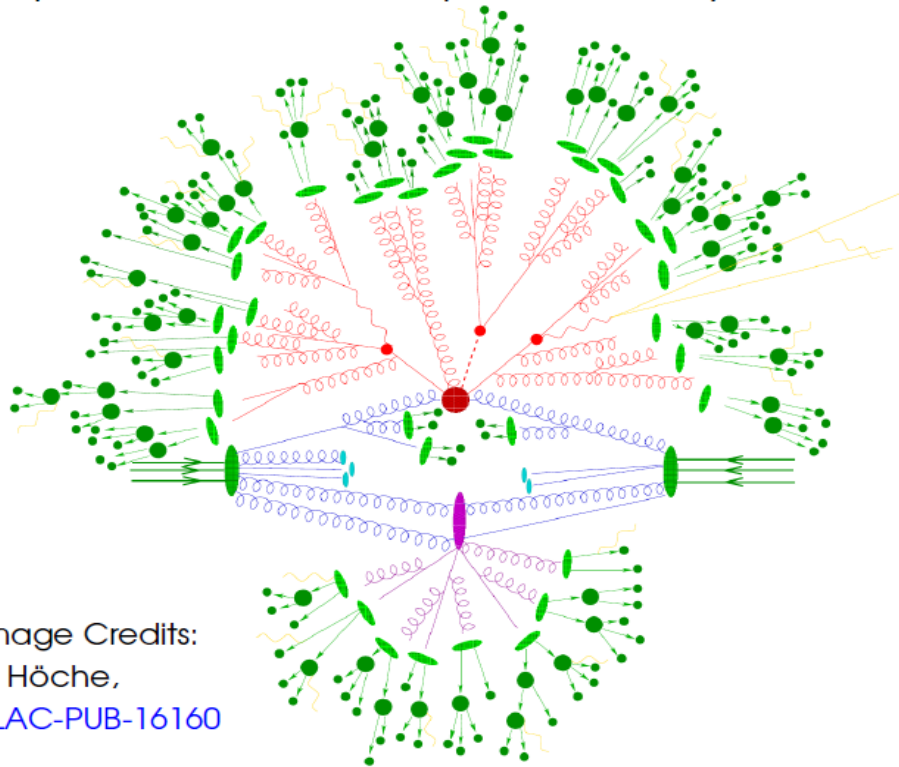


Image Credits:
S. Höche,
SLAC-PUB-16160

Randomness involved in all stages

→ **Classical** randomness: detector response

→ **Quantum** effects in particle production, decay

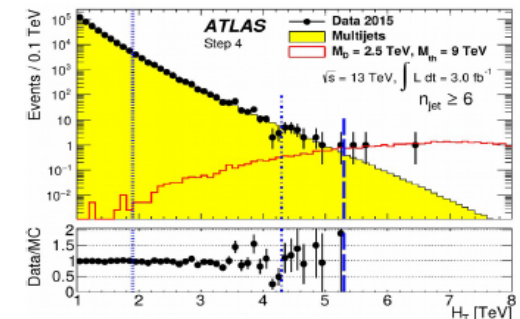
Hard scattering

PDFs, Parton shower, Pileup

Decays

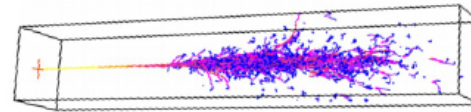
Detector response

Reconstruction

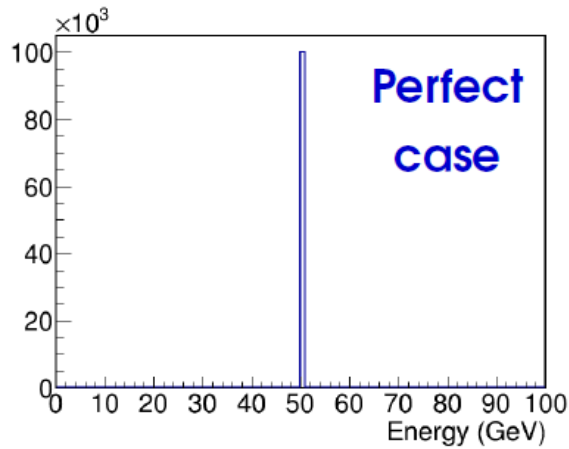
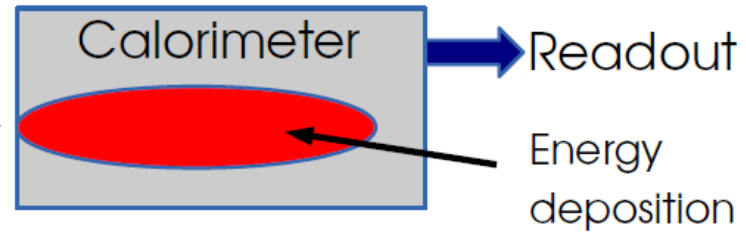


Measurement Errors: Energy measurement

Example: measuring the energy of a photon in a calorimeter

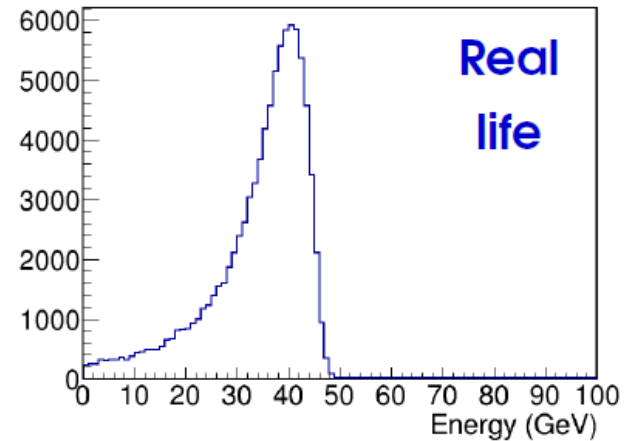
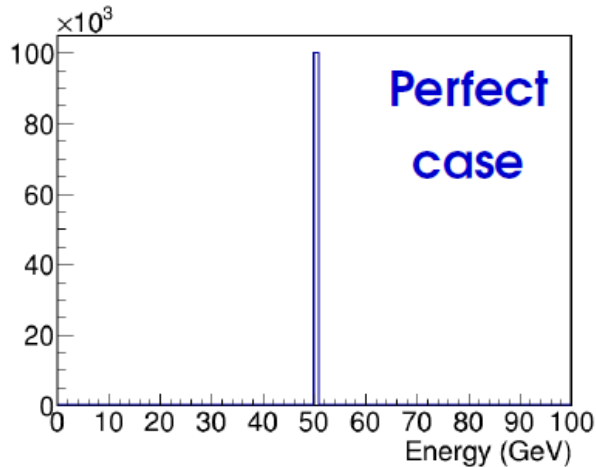
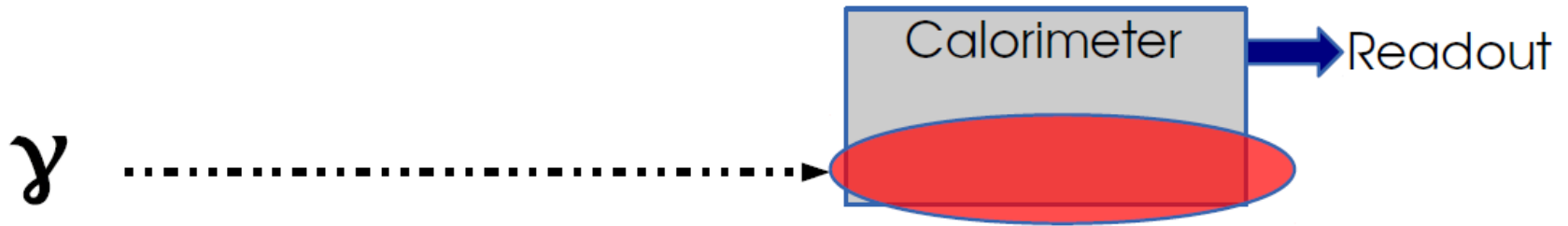
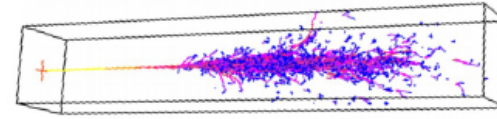


γ



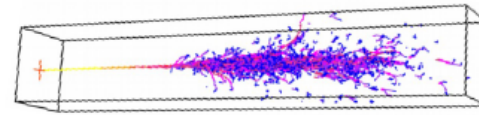
Measurement Errors: Energy measurement

Example: measuring the energy of a photon in a calorimeter



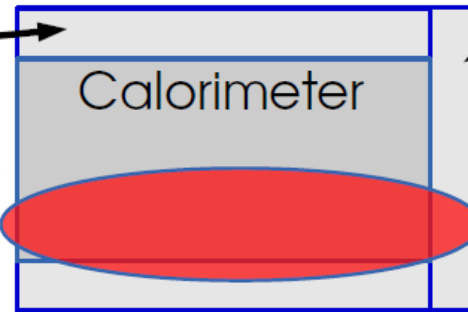
Measurement Errors: Energy measurement

Example: measuring the energy of a photon in a calorimeter



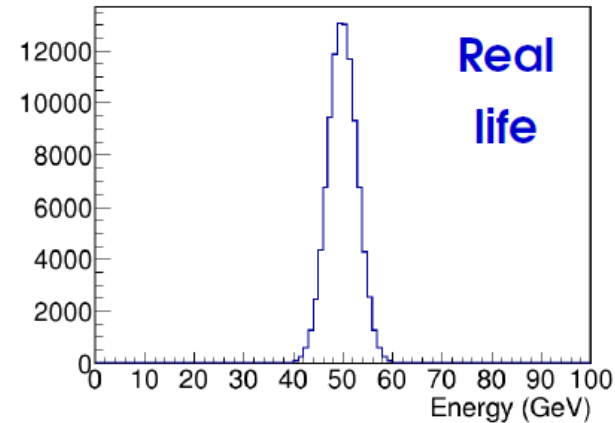
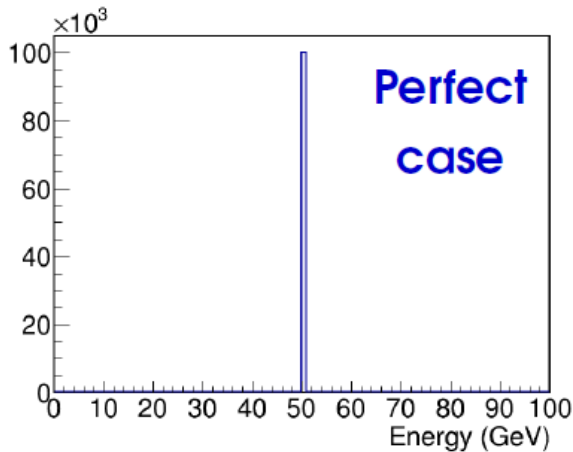
Measure leakage behind calorimeter

Measure leakage into neighboring cells



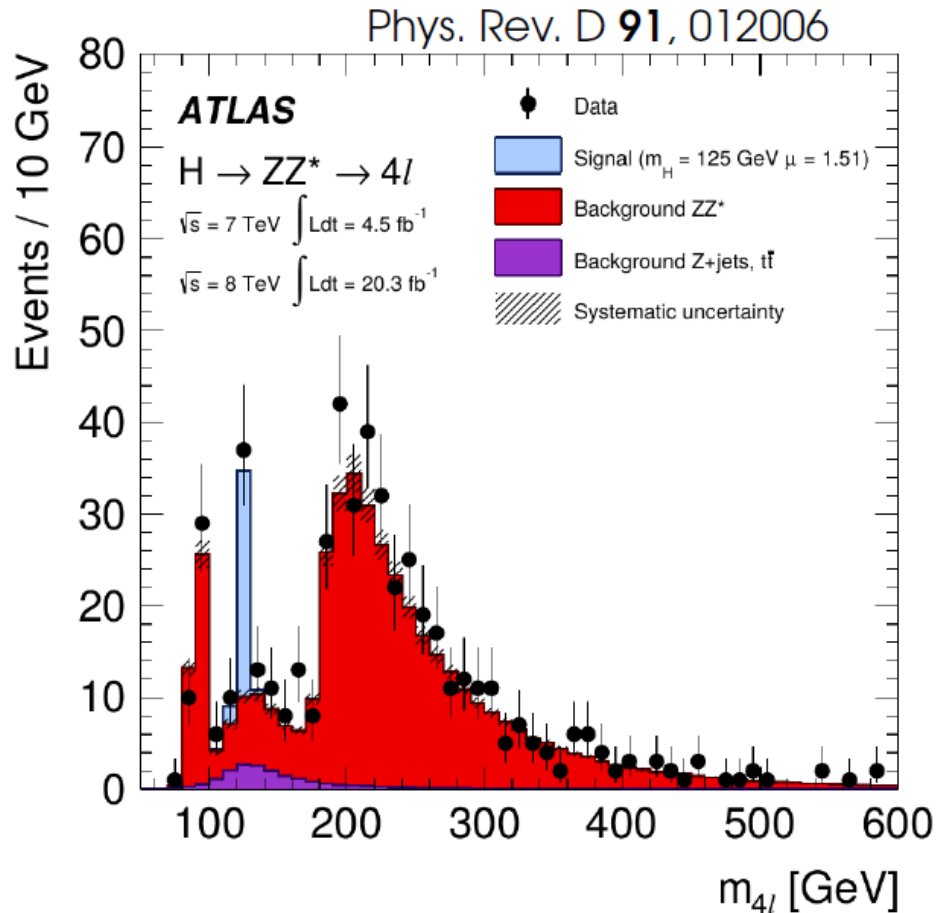
Readout

γ



Cannot predict the measured value for a given event
 \Rightarrow **Random process** \Rightarrow **Need a probabilistic description**

Quantum randomness: $H \rightarrow ZZ^* \rightarrow 4l$



Rare process: Expect 1 signal event every **~6 days**

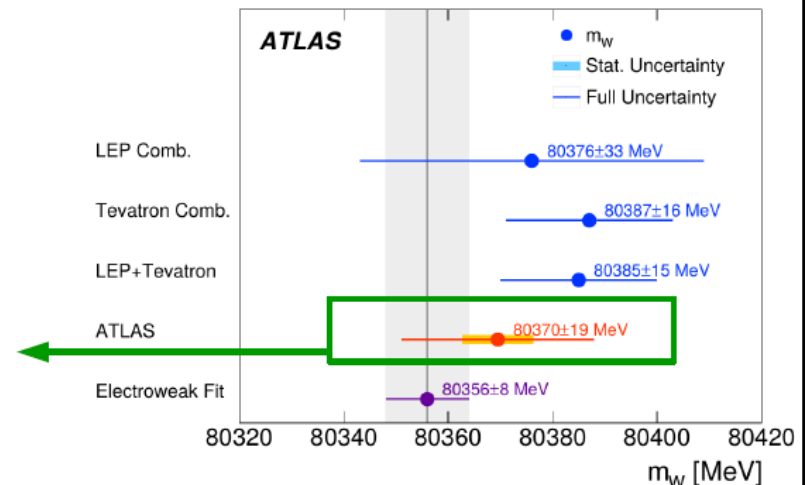
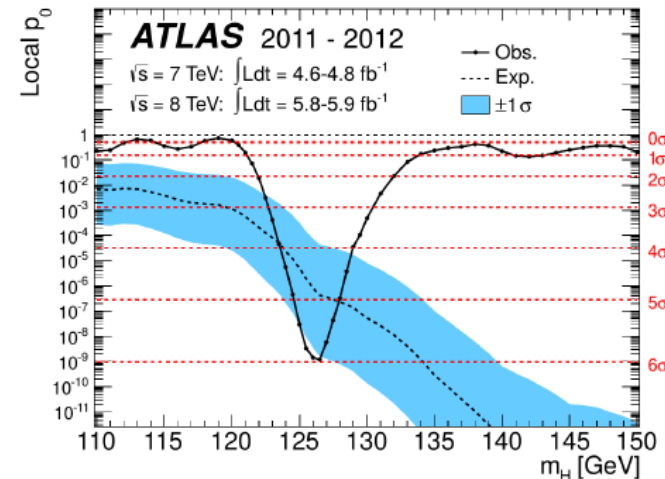
“Will I get an event today ?” → only **probabilistic** answer

Randomness in Physics

Questions with probabilistic answers:

- **Is my Higgs-like excess just a background fluctuation?**
 → associated with prob $\sim 10^{-9}$ (by now $\sim 10^{-24}$)
 ⇒ above the famous (and conventional) 5σ
- For measurements: probability that the **true value** of a parameter is within an interval:

68% chance that the true m_W is within the orange interval



Probability distributions

Probabilistic treatment of possible outcomes

⇒ **Probability Distribution**

Example: two-coin toss

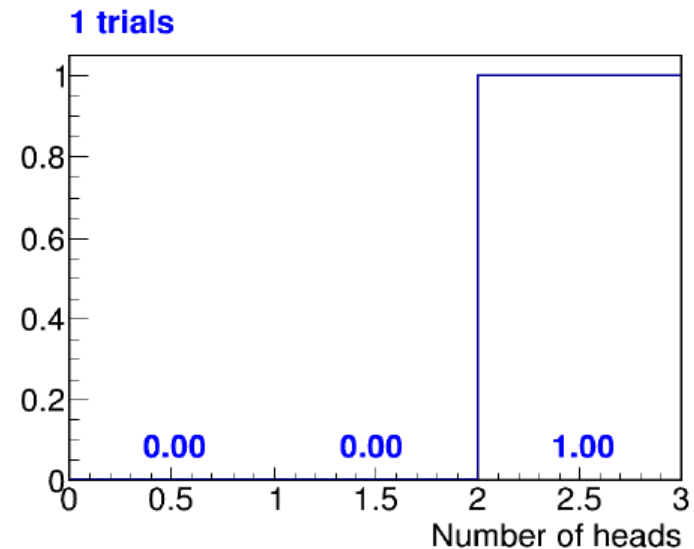
→ Fractions of events in each bin i
converge to a limit p_i

Probability distribution :

$\{ P_i \}$ for $i = 0, 1, 2$

Properties

- $P_i > 0$
- $\sum P_i = 1$



Probability distributions

Probabilistic treatment of possible outcomes

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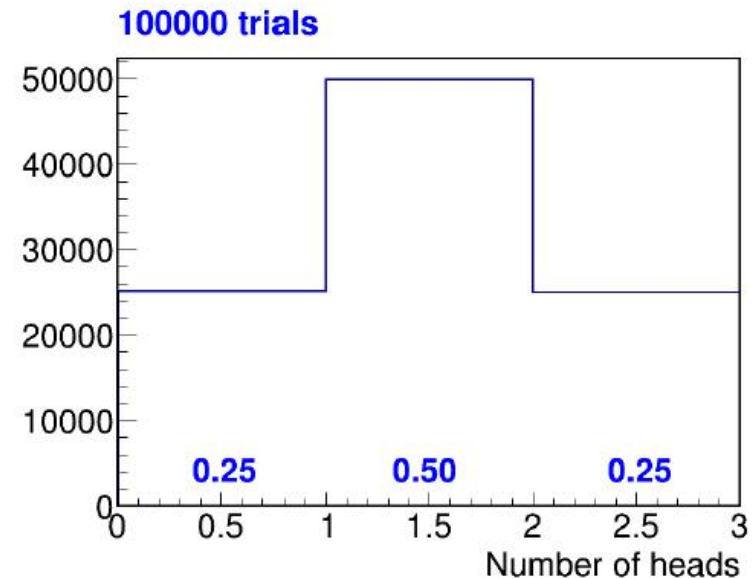
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Probabilistic treatment of possible outcomes

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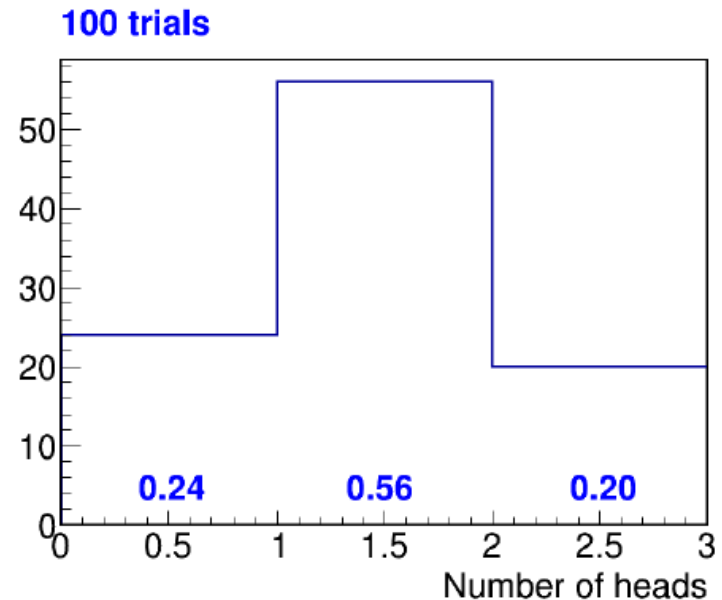
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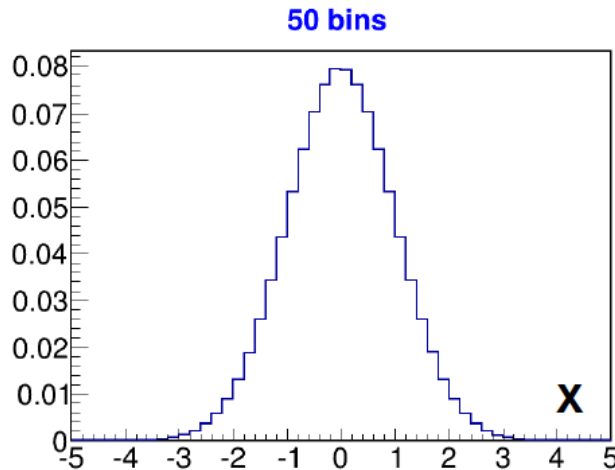
Properties

- $P_i > 0$
- $\sum P_i = 1$



Continuous Variables: PDFs

Continuous variable: can consider **per-bin** probabilities $p_i, i=1..n_{\text{bins}}$



Bin size $\rightarrow 0$:

Probability distribution function $P(x)$

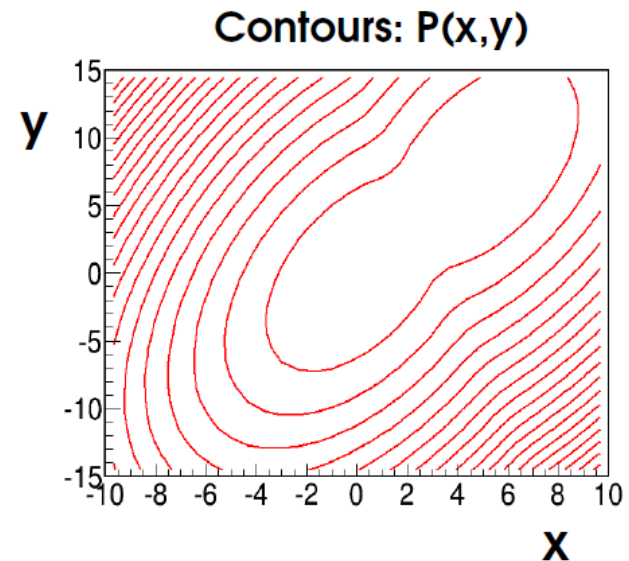
$\rightarrow P(x) > 0, \int P(x) dx = 1$

\rightarrow High values \Leftrightarrow high chance to get
a measurement here

Generalizes to **multiple variables** :

$\rightarrow P(x,y) > 0$

$\rightarrow \int P(x,y) dx dy = 1$

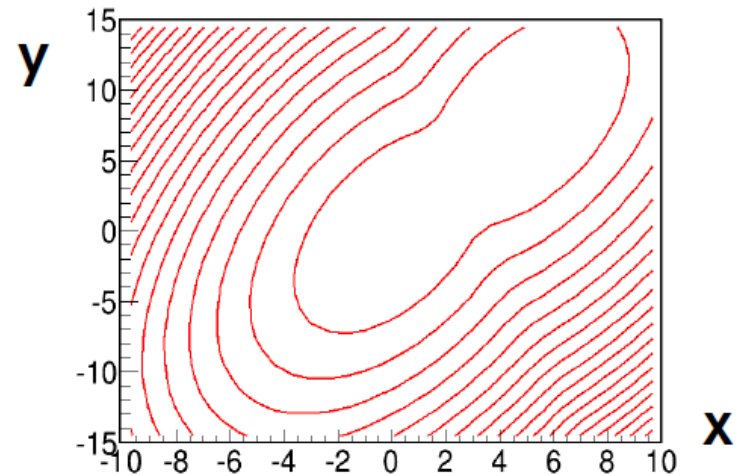
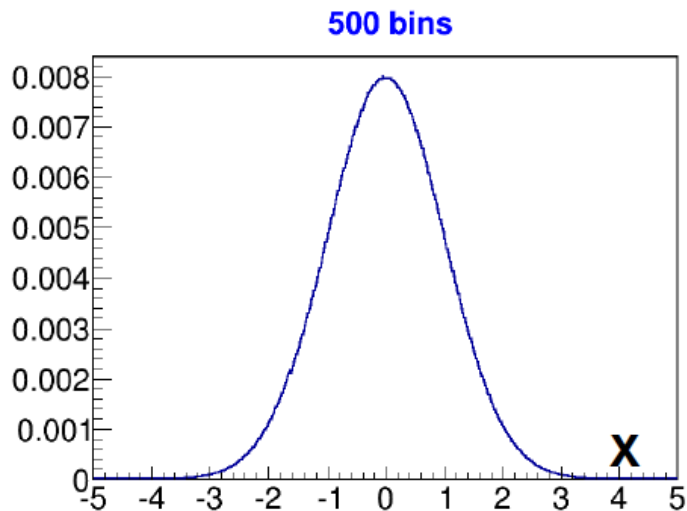
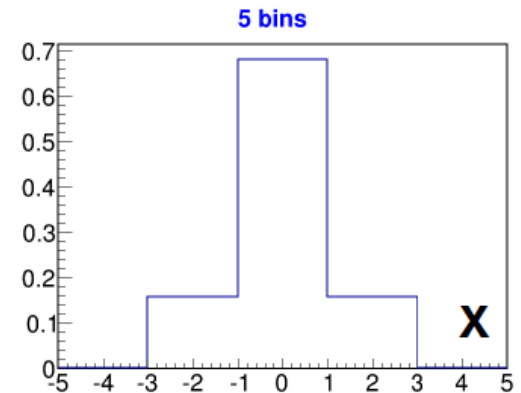


Random Variables

X, Y, \dots are **Random Variables** (continuous or discrete), a.k.a. **observables** :
→ X can take any value x , with probability **$P(X=x)$** .

→ $P(X)$ is the **PDF** of X , a.k.a. the **Statistical Model**.

→ The **Observed data** is **one value** x_{obs} of X ,
drawn from $P(X)$.



PDF properties: mean

$E(X) = \langle X \rangle$: **Mean** of X – expected outcome on average over many measurements

$$\langle X \rangle = \sum_i x_i P_i \quad \text{or}$$

$$\langle X \rangle = \int x P(x) dx$$

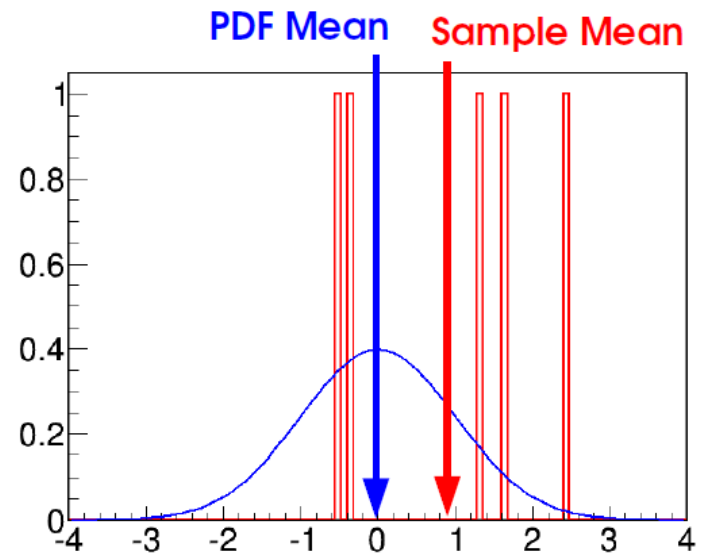
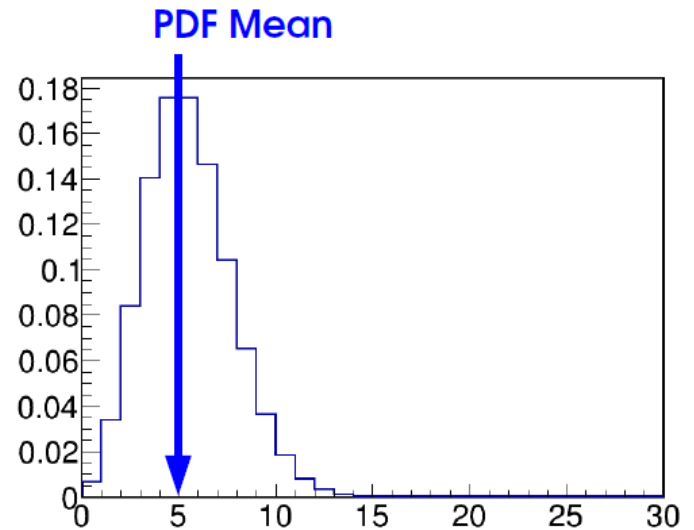
→ Property of the **PDF**

For measurements x_1, \dots, x_n ,
then can compute the **Sample mean**:

$$\bar{x} = \frac{1}{n} \sum_i x_i$$

→ Property of the **sample**

→ approximates the PDF mean.



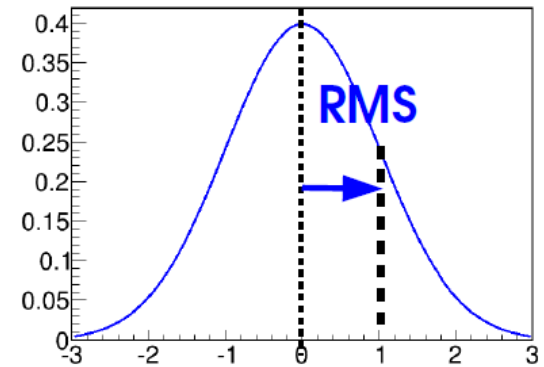
PDF properties: (co)variance

Variance of X:

$$\text{Var}(X) = \langle (X - \langle X \rangle)^2 \rangle$$

→ Average square of deviation from mean

→ $\text{RMS}(X) = \sqrt{\text{Var}(X)} = \sigma_x$ **standard deviation**



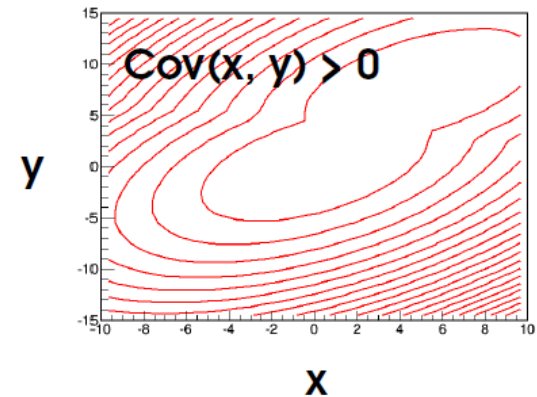
Can be approximated by **sample variance**:

$$\hat{\sigma}^2 = \frac{1}{n-1} \sum_i (x_i - \bar{x})^2$$

Covariance of X and Y:

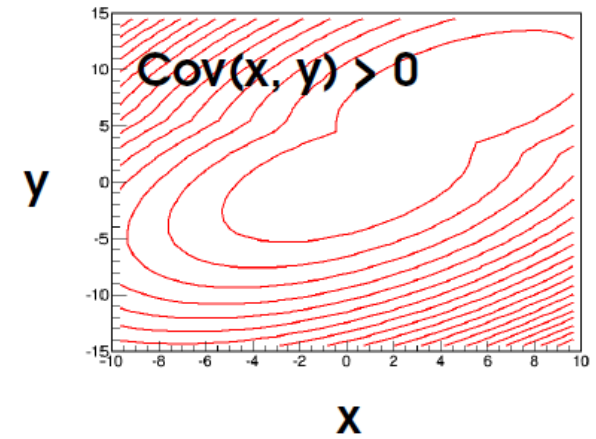
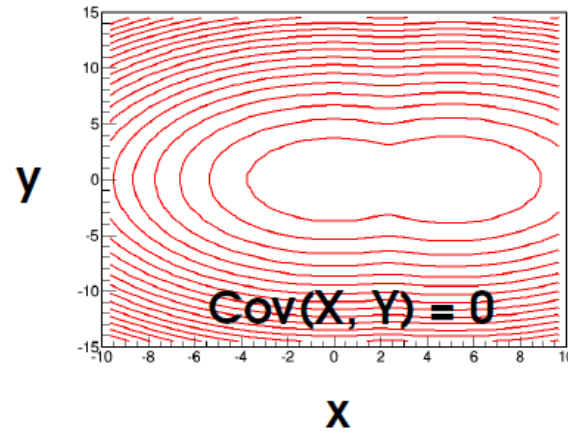
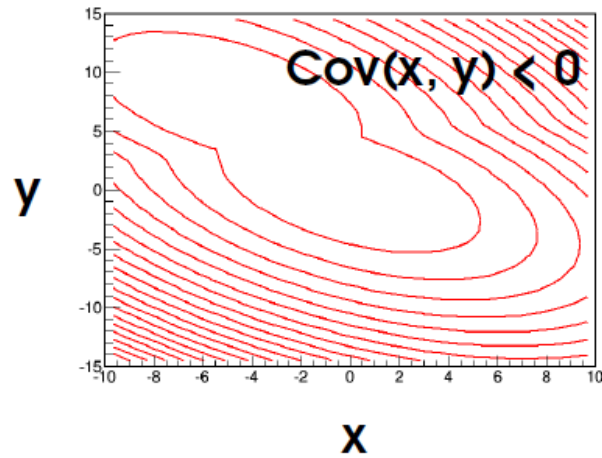
$$\text{Cov}(X, Y) = \langle (X - \langle X \rangle)(Y - \langle Y \rangle) \rangle$$

→ Large if variations of X and Y are “synchronized”



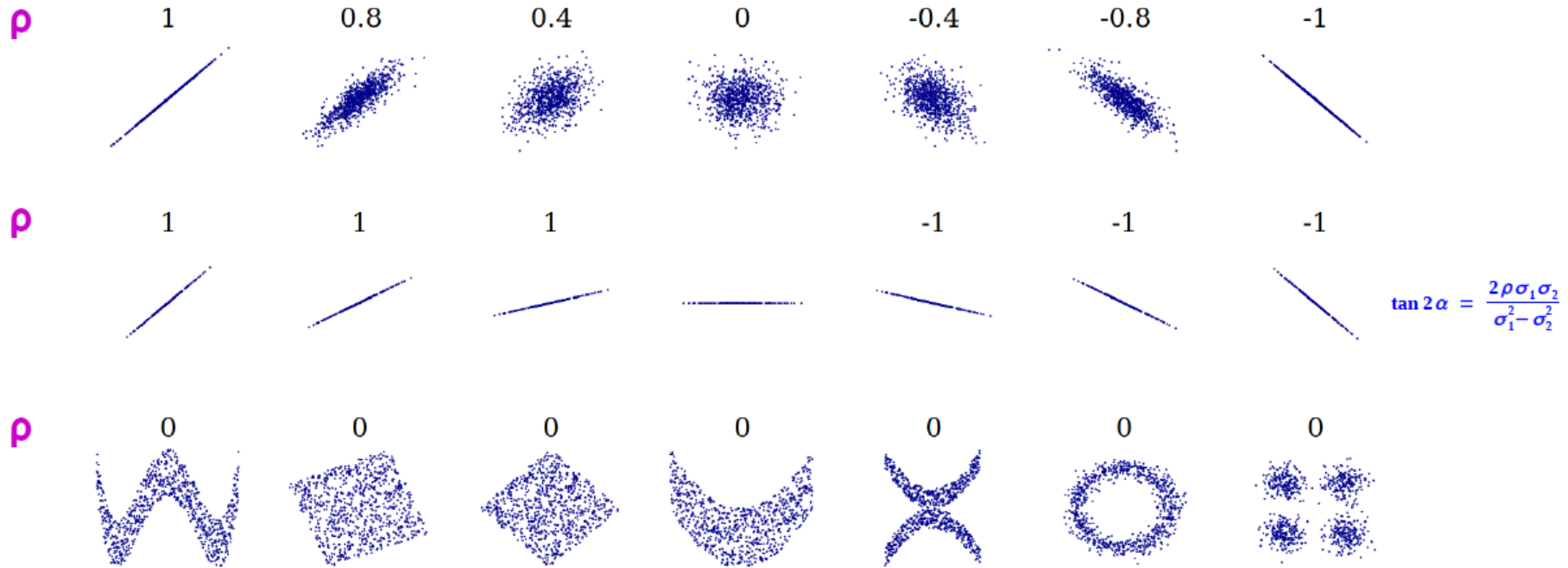
Correlation coefficient $\rho = \frac{\text{Cov}(X, Y)}{\sqrt{\text{Var}(X) \text{Var}(Y)}} \quad -1 \leq \rho \leq 1$

PDF properties: (co)variance



„Linear” vs. „non-linear” correlations

For non-Gaussian cases, the **Correlation coefficient ρ** is not the whole story:



Source: [Wikipedia](#)

In particular, variables can still be correlated even when $\rho=0$: “*Non-linear*” correlations.

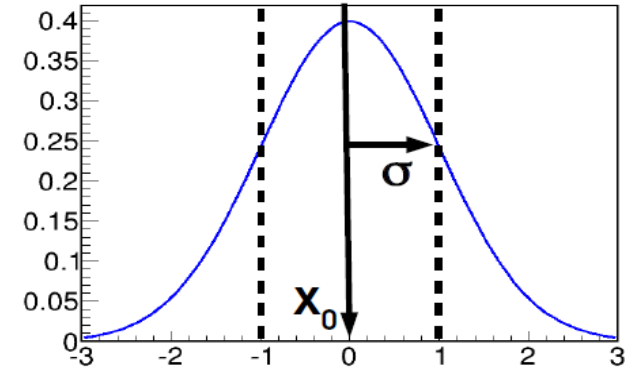
Gaussian PDF

Gaussian distribution:

$$G(\mathbf{x}; \mathbf{X}_0, \sigma) = \frac{1}{\sigma \sqrt{2\pi}} e^{-\frac{(x - X_0)^2}{2\sigma^2}}$$

→ Mean : X_0

→ Variance : σ^2 (\Rightarrow RMS = σ)



Generalize to **N** dimensions:

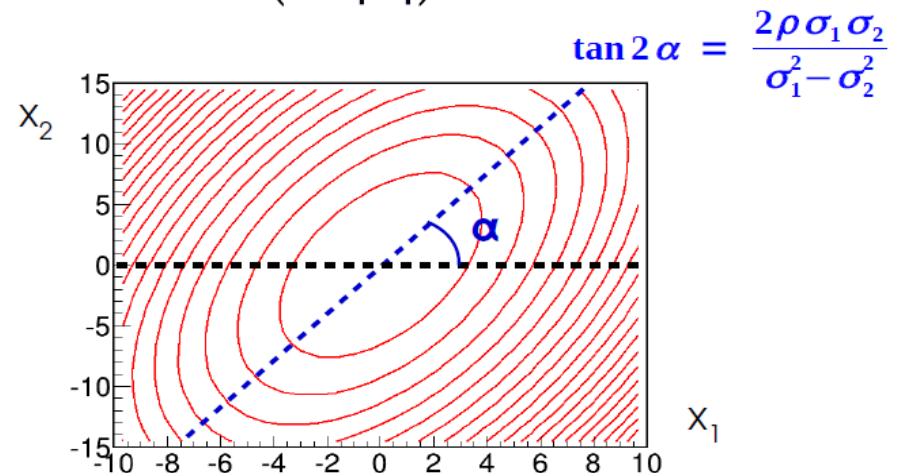
→ Mean : \mathbf{X}_0

→ Covariance matrix :

$$C = \begin{bmatrix} \text{Var}(X_1) & \text{Cov}(X_1, X_2) \\ \text{Cov}(X_2, X_1) & \text{Var}(X_2) \end{bmatrix}$$

$$= \begin{bmatrix} \sigma_1^2 & \rho \sigma_1 \sigma_2 \\ \rho \sigma_1 \sigma_2 & \sigma_2^2 \end{bmatrix}$$

$$G(\mathbf{x}; \mathbf{X}_0, C) = \frac{1}{(2\pi|C|)^{N/2}} e^{-\frac{1}{2}(\mathbf{x} - \mathbf{X}_0)^T C^{-1}(\mathbf{x} - \mathbf{X}_0)}$$



Gaussian quantiles

Consider $z = \left(\frac{x - x_0}{\sigma} \right)$ "pull" of x

$G(x; x_0, \sigma)$ depends only on $z \sim G(z; 0, 1)$

Probability $P(|x - x_0| > Z\sigma)$ to be away from the mean:

Z	$P(x - x_0 > Z\sigma)$
1	0.317
2	0.045
3	0.003
4	3×10^{-5}
5	6×10^{-7}

Gaussian **Cumulative Distribution Function (CDF)** :

$$\Phi(z) = \int_{-\infty}^z G(u; 0, 1) du$$

In ROOT,

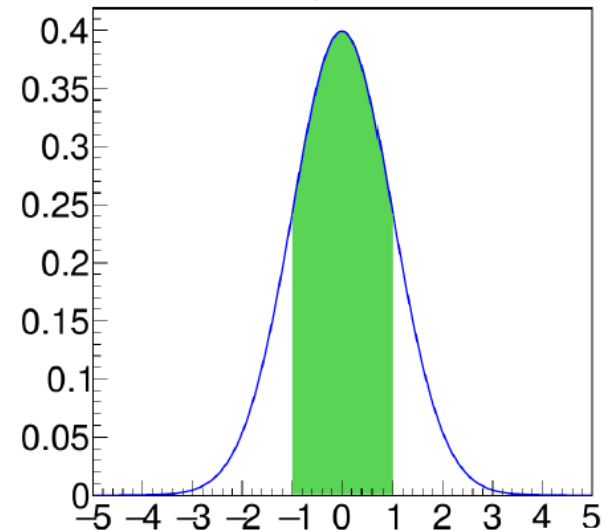
$\Phi(z)$: `ROOT::Math::gaussian_cdf(z)`

$\Phi^{-1}(p)$: `ROOT::Math::gaussian_quantile(p, 1)`

and add "_c" to use $1 - \Phi$ instead of Φ

```
root [0] ROOT::Math::gaussian_cdf(1) - ROOT::Math::gaussian_cdf(-1)
(double) 0.68268949
root [1] ROOT::Math::gaussian_quantile_c(0.05/2, 1)
(double) 1.9599640
```

$P(|x - x_0| < 1\sigma) = 68.3\%$



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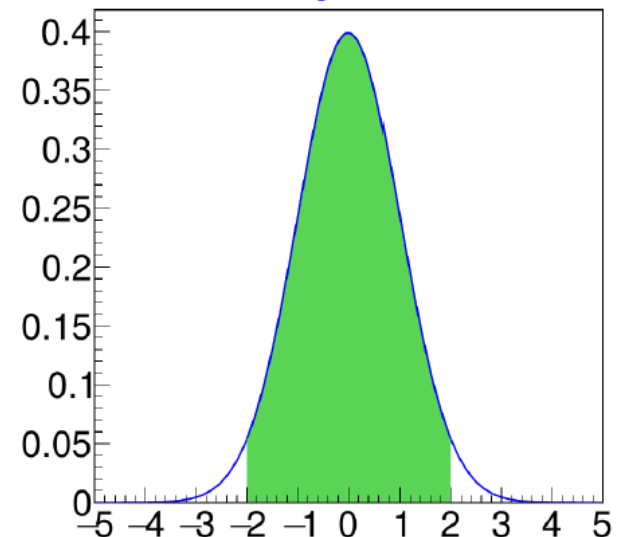
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```

$P(|x - x_0| < 2\sigma) = 95.4 \%$



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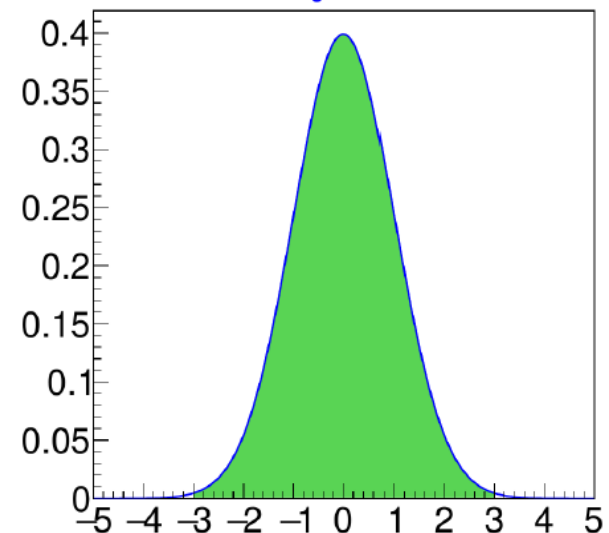
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(double) 0.68268949
root [1] ROOT::Math::gaussian_quantile_c(0.05/2, 1)
(double) 1.9599640
```

$P(|x - x_0| < 3\sigma) = 99.7\%$



Central Limit Theorem

(*) Assuming $\sigma_x < \infty$
and other regularity
conditions

For an observable X with **any distribution**, one has(*)

$$\bar{x} = \frac{1}{n} \sum_{i=1}^n x_i \stackrel{n \rightarrow \infty}{\sim} G\left(\langle X \rangle, \frac{\sigma_X}{\sqrt{n}}\right)$$

What this means:

- **The average of many measurements is always Gaussian**, whatever the distribution for a single measurement
- The **mean** of the Gaussian is the **average of the single measurements**
- The **RMS** of the Gaussian **decreases as \sqrt{n}** : smaller fluctuations when averaging over many measurements

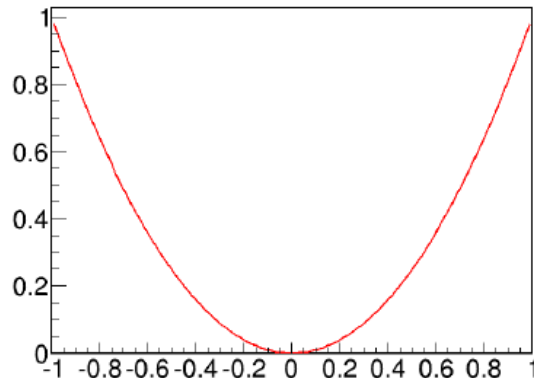
Another version,
for the sum:

$$\sum_{i=1}^n x_i \stackrel{n \rightarrow \infty}{\sim} G\left(n \langle X \rangle, \sqrt{n} \sigma_X\right)$$

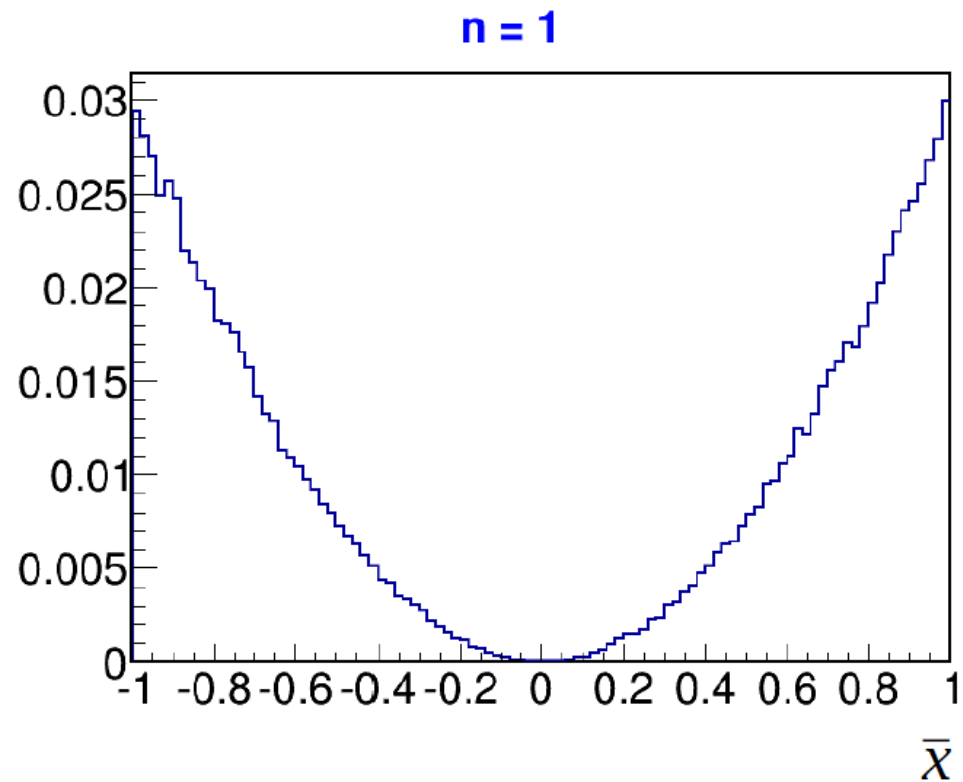
Mean scales like n , but RMS only like \sqrt{n}

Central Limit Theorem in action

Draw events from a parabolic distribution (e.g. decay $\cos \theta^*$)



$$\bar{x} = \frac{1}{n} \sum_{i=1}^n x_i \quad \longrightarrow$$

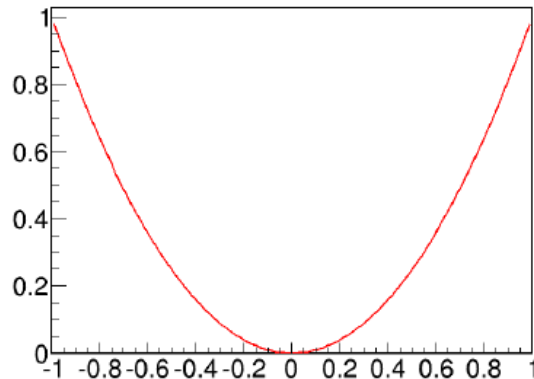


Distribution becomes Gaussian, although very non-Gaussian originally

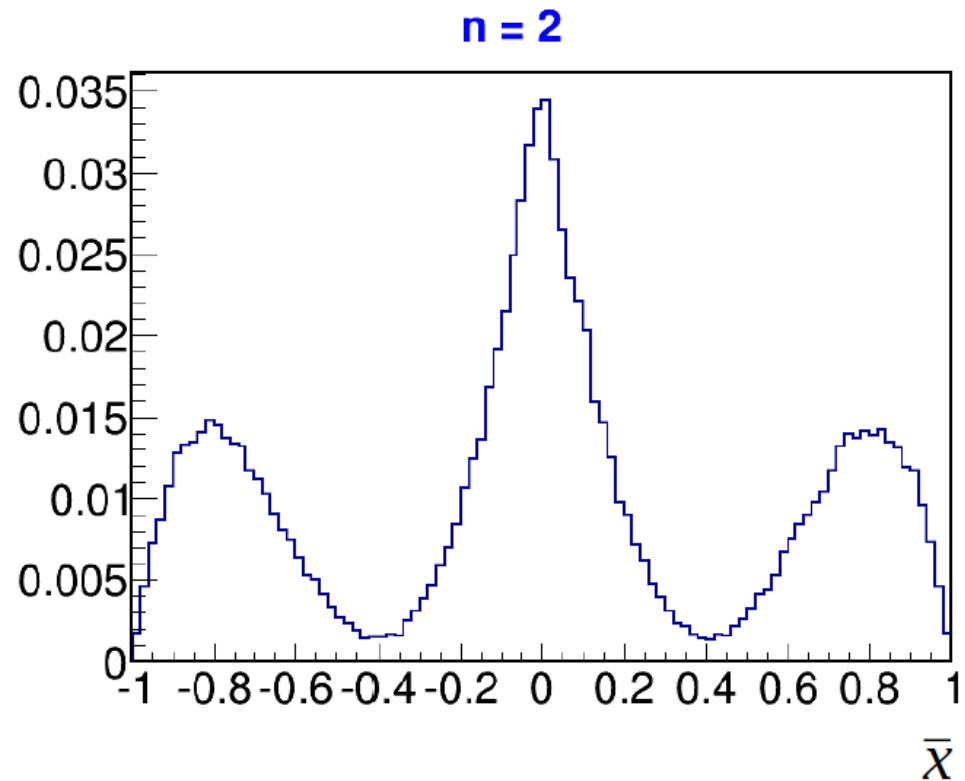
Distribution becomes narrower as expected (as $1/\sqrt{n}$)

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Draw events from a parabolic distribution (e.g. decay $\cos \theta^*$)



$$\bar{x} = \frac{1}{n} \sum_{i=1}^n x_i \quad \longrightarrow$$

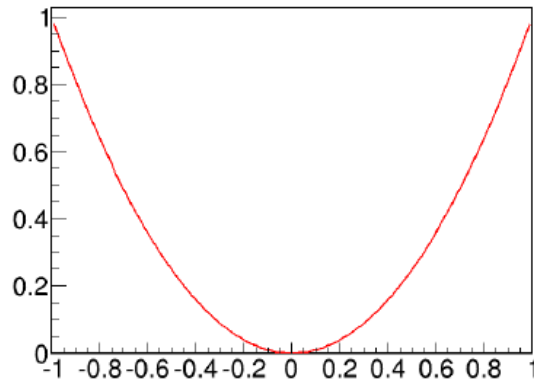


Distribution becomes Gaussian, although very non-Gaussian originally

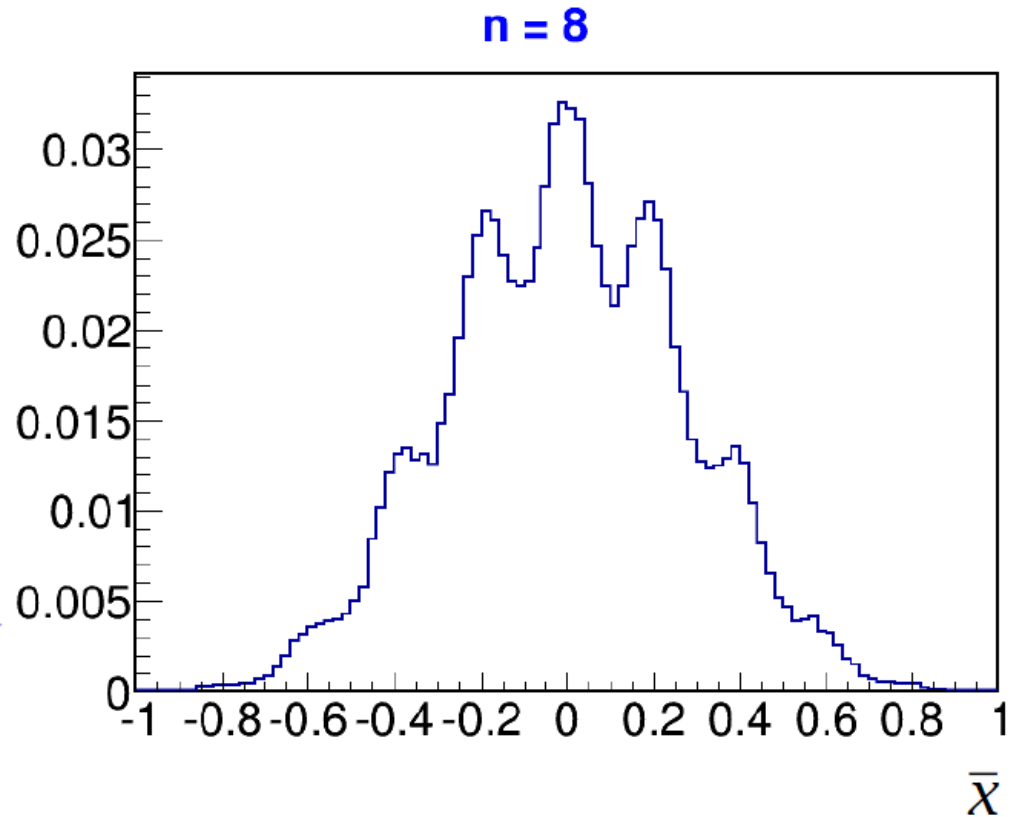
Distribution becomes narrower as expected (as $1/\sqrt{n}$)

Central Limit Theorem in action

Draw events from a parabolic distribution (e.g. decay $\cos \theta^*$)



$$\bar{x} = \frac{1}{n} \sum_{i=1}^n x_i \quad \longrightarrow$$

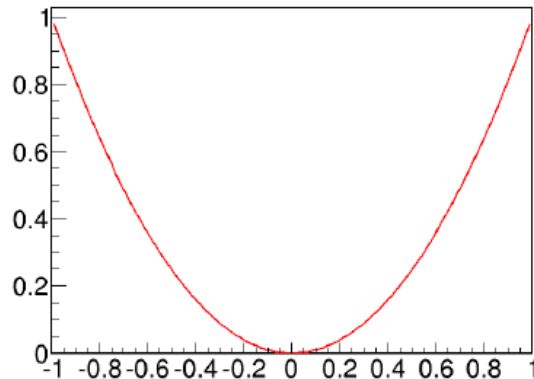


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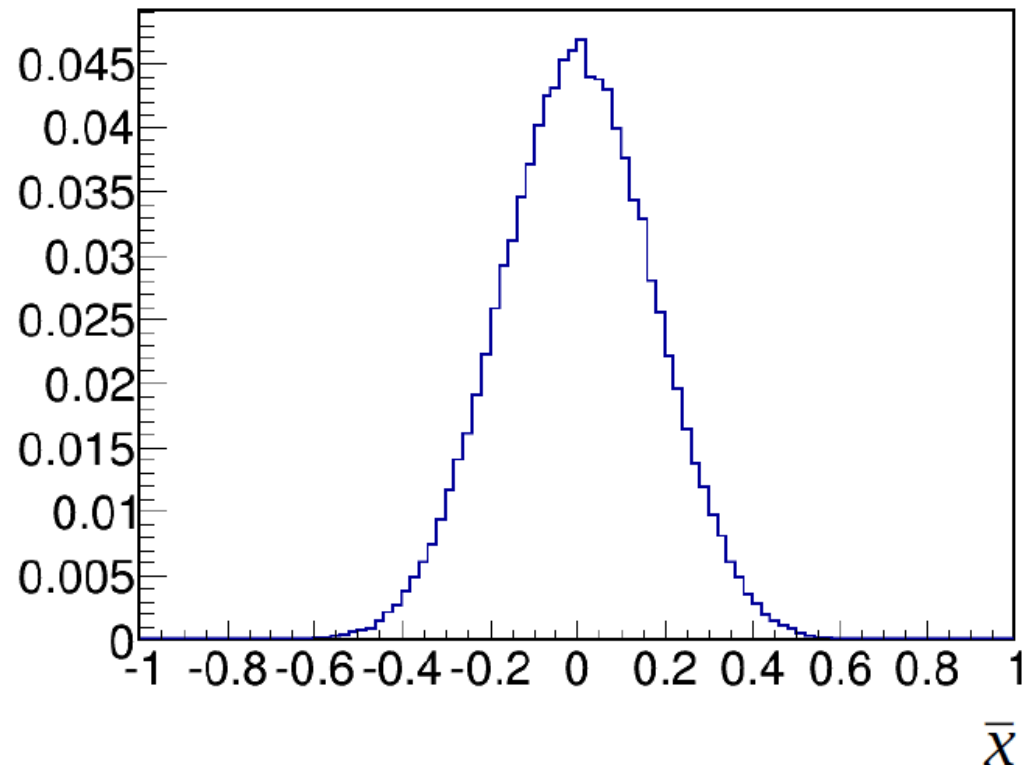
Central Limit Theorem in action

Draw events from a parabolic distribution (e.g. decay $\cos \theta^*$)



n = 20

$$\bar{x} = \frac{1}{n} \sum_{i=1}^n x_i \quad \longrightarrow$$

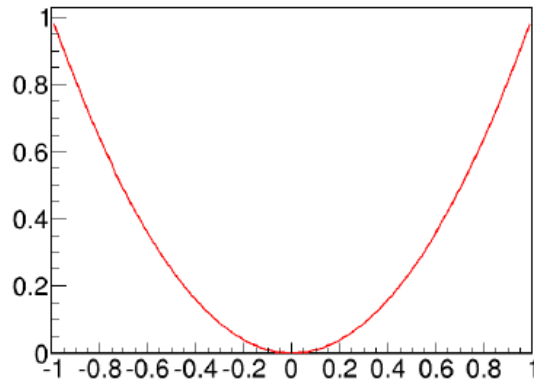


Distribution becomes Gaussian, although very non-Gaussian originally

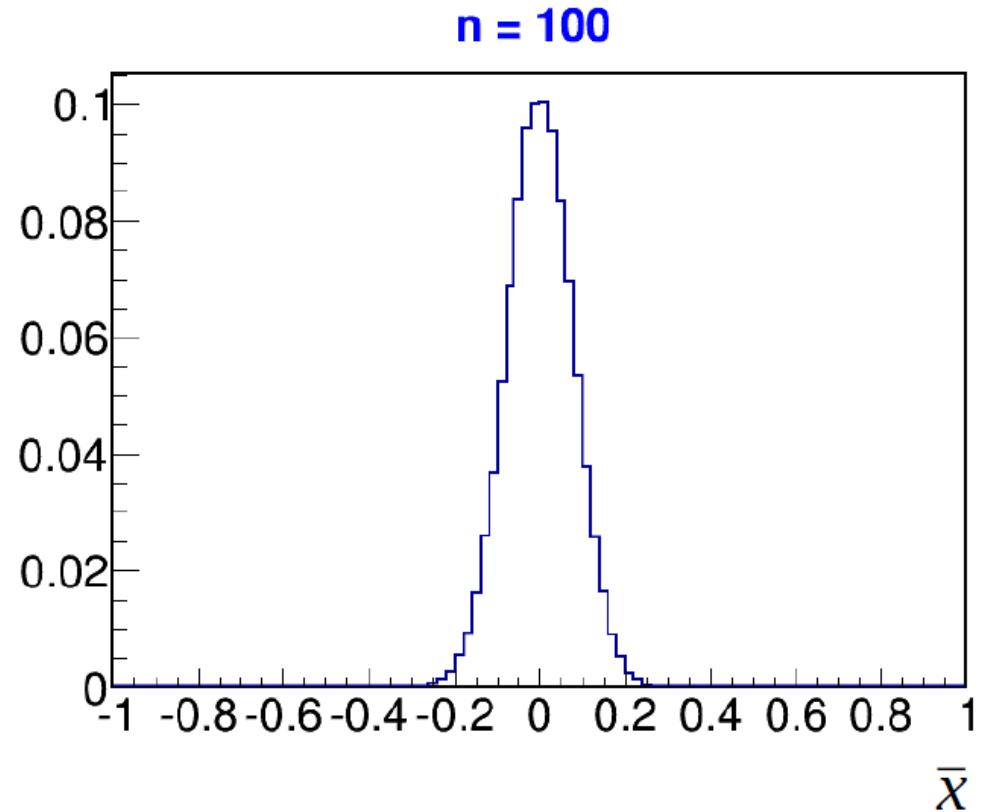
Distribution becomes narrower as expected (as $1/\sqrt{n}$)

Central Limit Theorem in action

Draw events from a parabolic distribution (e.g. decay $\cos \theta^*$)



$$\bar{x} = \frac{1}{n} \sum_{i=1}^n x_i \quad \longrightarrow$$



Distribution becomes Gaussian, although very non-Gaussian originally

Distribution becomes narrower as expected (as $1/\sqrt{n}$)

Chi-squared

Chi-squared

Multiple Independent Gaussian variables x_i : Define

$$\chi^2 = \sum_{i=1}^n \left(\frac{x_i - x_i^0}{\sigma_i} \right)^2$$

Measures global distance from reference point (x_1^0, \dots, x_n^0)

Distribution depends on n :

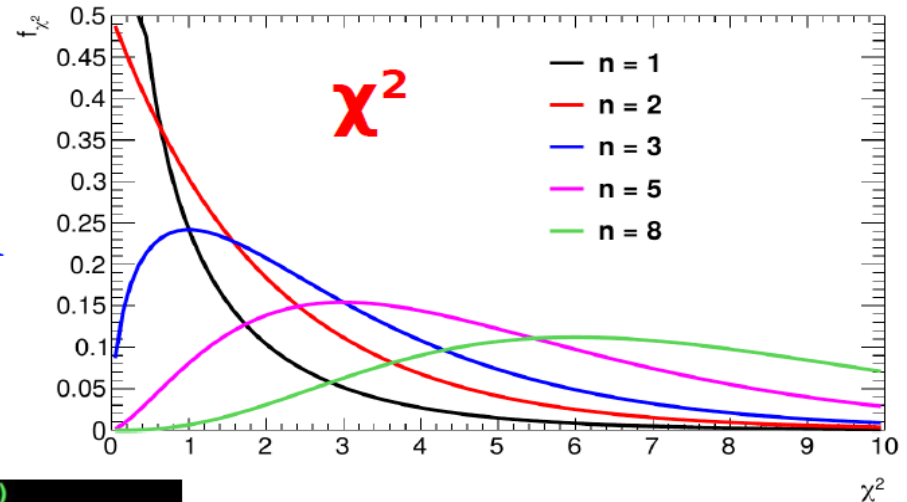
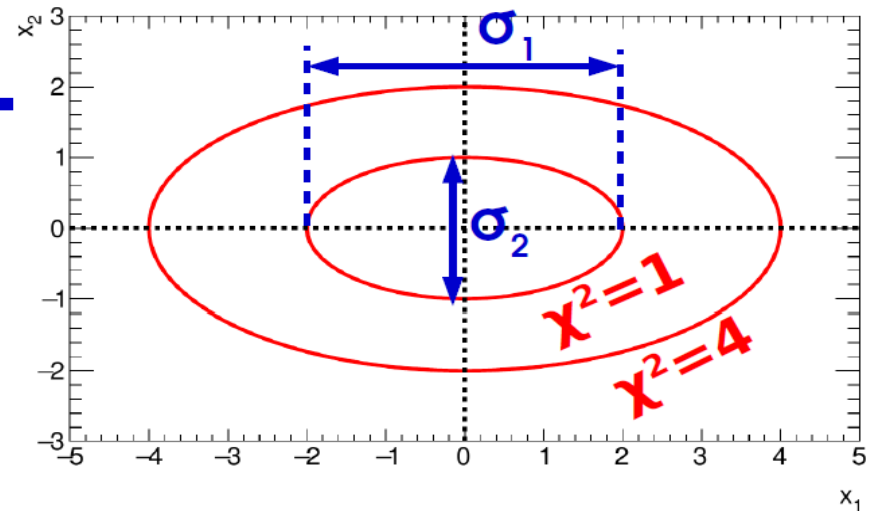
Rule of thumb: χ^2/n should be $\lesssim 1$

Exact distributions in ROOT:

ROOT::Math::chisquared_pdf(x, n)

ROOT::Math::chisquared_cdf(x, n)

```
root [0] ROOT::Math::chisquared_cdf(1, 1)
(double) 0.68268949
root [1] ROOT::Math::chisquared_cdf(4, 1)
(double) 0.95449974
```



Chi-squared

Multiple Independent Gaussian variables x_i : Define

$$\chi^2 = \sum_{i=1}^n \left(\frac{x_i - x_i^0}{\sigma_i} \right)^2$$

Measures global distance from reference point (x_1^0, \dots, x_n^0)

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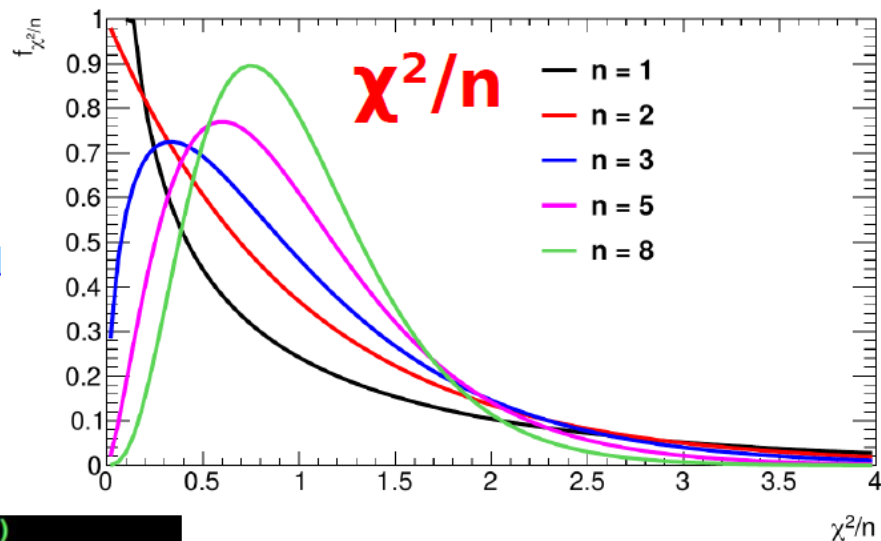
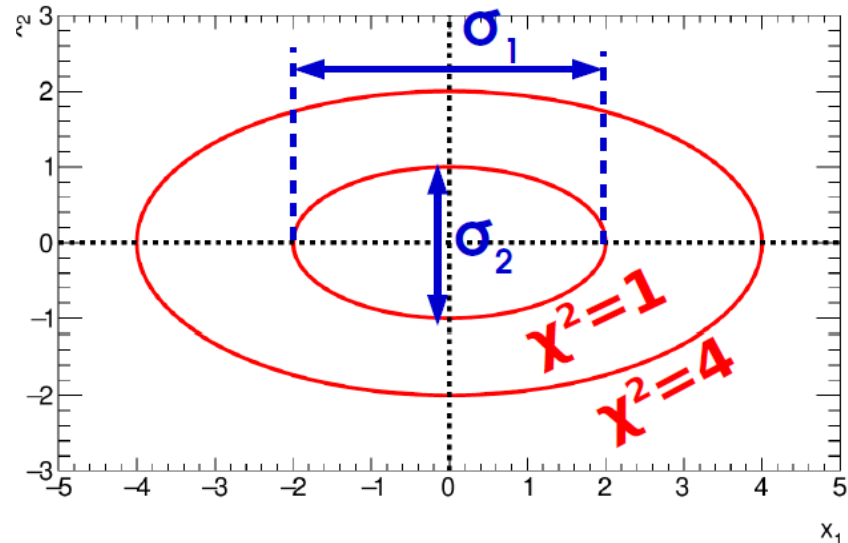
Rule of thumb: χ^2/n should be ≈ 1

Exact distributions in ROOT:

ROOT::Math::chisquared_pdf(x, n)

ROOT::Math::chisquared_cdf(x, n)

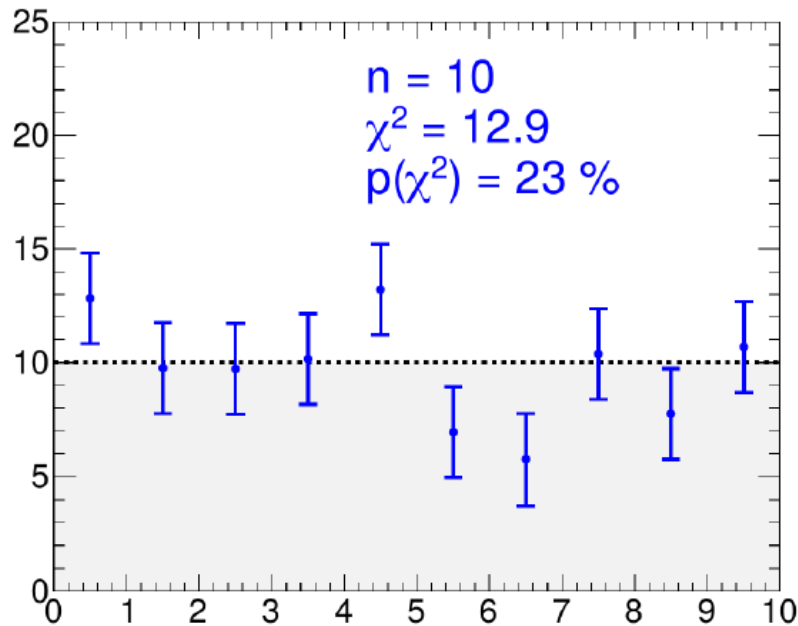
```
root [0] ROOT::Math::chisquared_cdf(1, 1)
(double) 0.68268949
root [1] ROOT::Math::chisquared_cdf(4, 1)
(double) 0.95449974
```



Histogram Chi-squared

Histogram χ^2 with respect to a reference shape:

- Assume an independent Gaussian distribution in each bin
- Degrees of freedom = (number of bins) – (number of fit parameters)



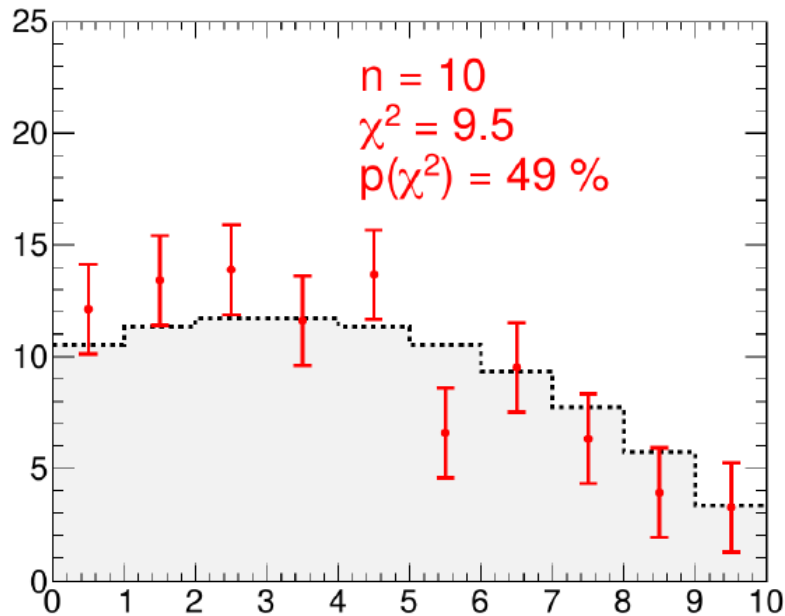
BLUE histogram vs. flat reference

$\chi^2 = 12.9$, $p(\chi^2=12.9, n=10) = 23\%$ ✓

Histogram Chi-squared

Histogram χ^2 with respect to a reference shape:

- Assume an independent Gaussian distribution in each bin
- Degrees of freedom = (number of bins) – (number of fit parameters)



BLUE histogram vs. flat reference

$$\chi^2 = 12.9, \quad p(\chi^2=12.9, n=10) = 23\% \quad \checkmark$$

RED histogram vs. flat reference

$$\chi^2 = 38.8, \quad p(\chi^2=38.8, n=10) = 0.003\% \quad \times$$

RED histogram vs. correct reference

$$\chi^2 = 9.5, \quad p(\chi^2=9.5, n=10) = 49\% \quad \checkmark$$

ROOT commands:

```
root [0] ROOT::Math::chisquared_cdf_c(12.9, 10)
(double) 0.22931681
root [1] ROOT::Math::chisquared_cdf_c(38.8, 10)
(double) 2.7519383e-05
```

Error Bars

Strictly speaking, **the uncertainty is given by the model** :

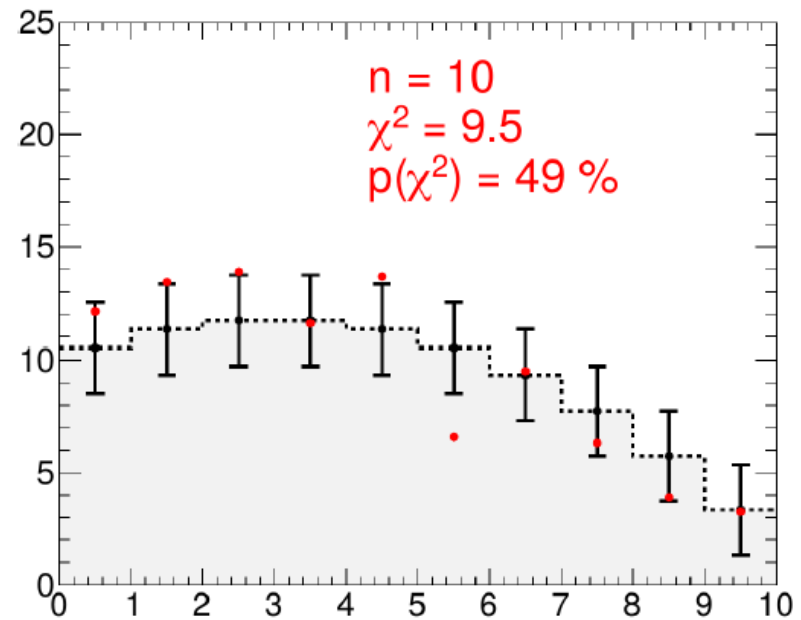
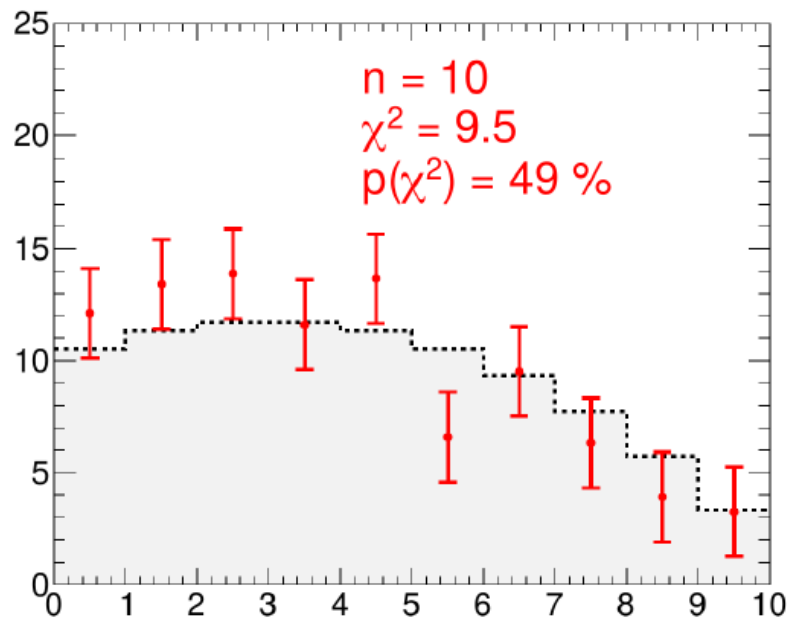
→ **Bin central value** ~ mean of the bin PDF

→ **Bin uncertainty** ~ RMS of the bin PDF

The data is just what it is, a simple observed point.

⇒ One should in principle **show the error bar on the prediction**.

→ In practice, the usual convention is to have **error bars on the data points**.



Example analyses

Example 1: $Z \rightarrow ee$ Inclusive σ^{fid}

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Measurement Principle:

$$\sigma^{\text{fid}} = \frac{n_{\text{data}} - N_{\text{bkg}}}{C_{\text{fid}} L}$$

35000 ± 187 (points to n_{data})
 175 ± 8 (points to N_{bkg})
 $(81 \pm 2) \text{ pb}^{-1}$ (points to L)
 0.552 ± 0.006 (points to C_{fid})

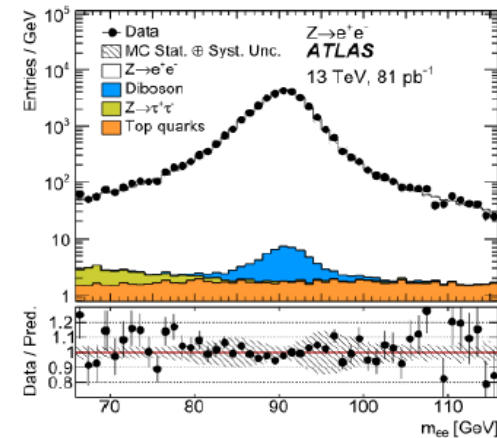
Simple uncertainty propagation:

$$\sigma^{\text{fid}} = 0.781 \pm 0.004 \text{ (stat)} \pm 0.008 \text{ (syst)} \pm 0.016 \text{ (lumi) nb}$$

→ Simplest possible example in several ways (from the Statistics point of view!)

→ “Single bin counting”: only data input is n_{data} .

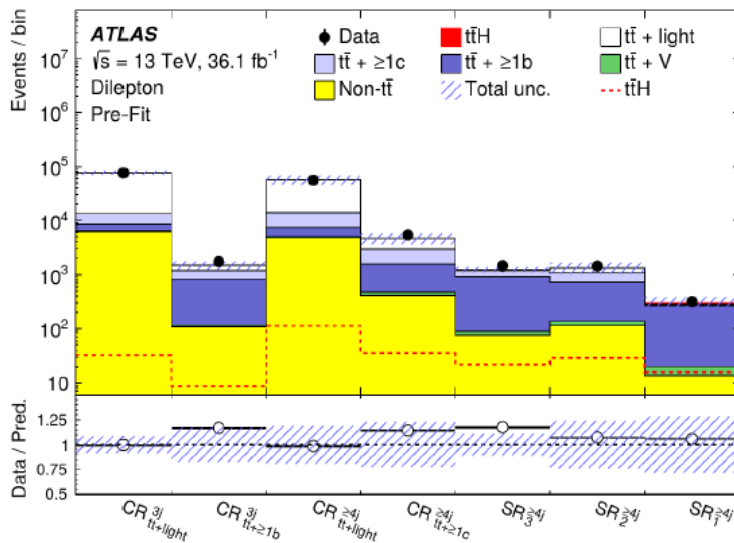
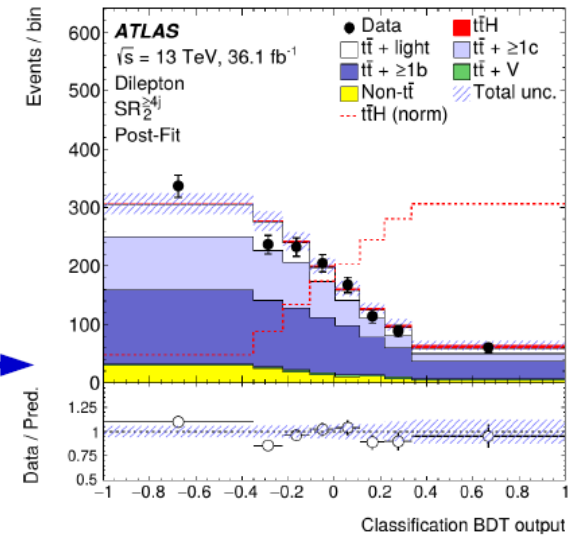
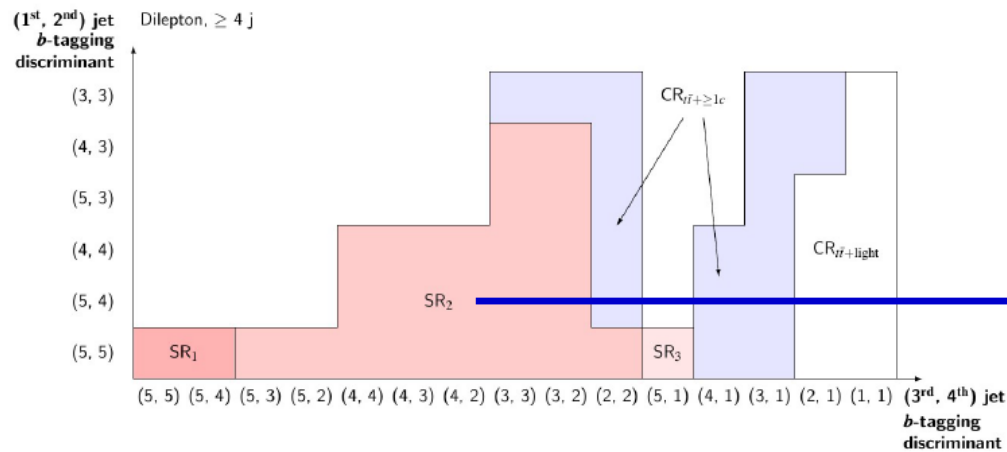
Signal events	$34865 \pm 187 \pm 7 \pm 3$
Correction C	$0.552^{+0.006}_{-0.005}$
σ^{fid} [nb]	$0.781 \pm 0.004 \pm 0.008 \pm 0.016$



Example analyses

Example 2: $t\bar{t}H \rightarrow bb$

arXiv:1712.008895



Event counting in different regions:
Multiple-bin counting

Lots of information available

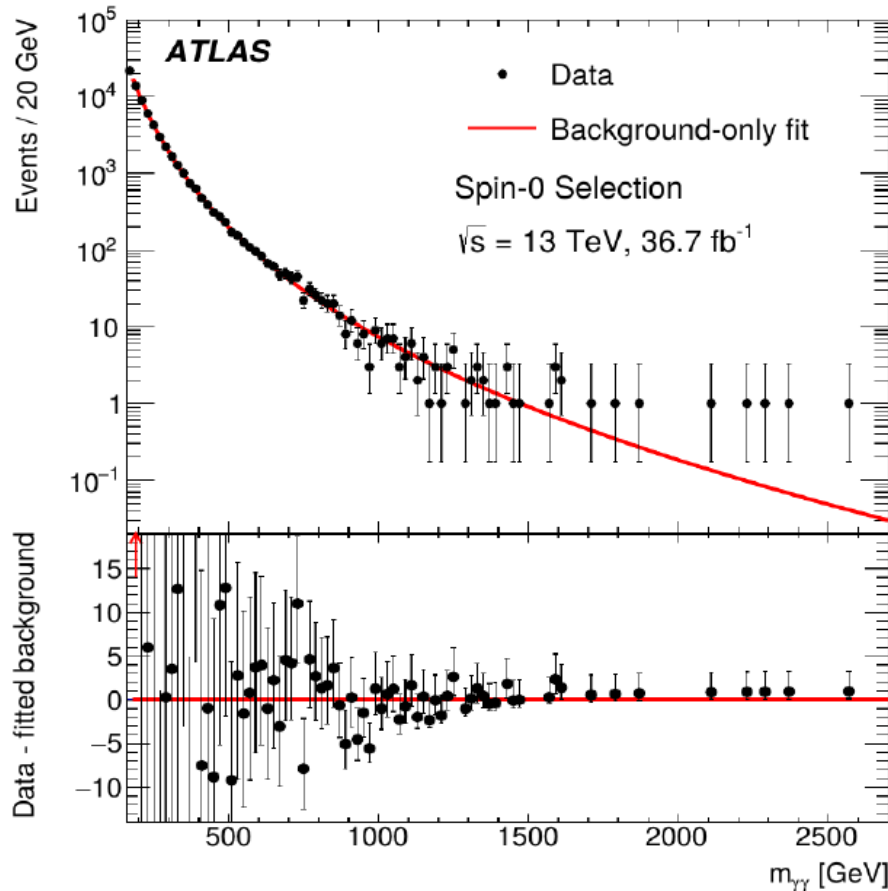
→ Potentially higher sensitivity

→ How to make optimal use of it ?

Example analyses

Example 3: Unbinned shape analysis

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Describe spectrum without discrete binning
→ use smooth functions of a continuous variable.

Unbinned shape analysis

→ No binning effects
→ Use all available information

→ How to describe the shapes ?

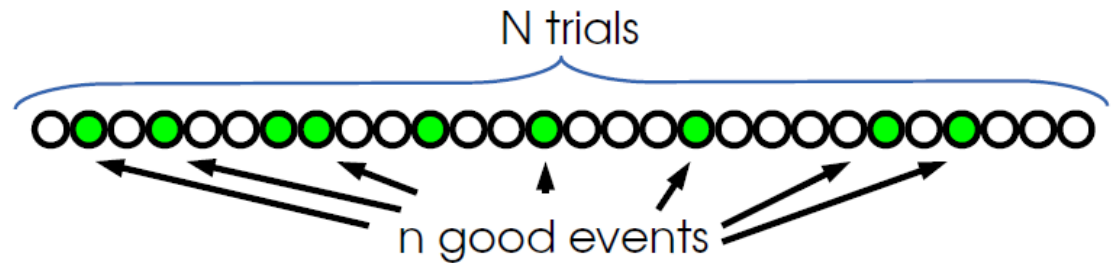
Counting events

Consider N total events, select **good** events with probability p .
Probability to get n good events ?

Binomial distribution : $P(n; N, p) = C_N^n p^n (1-p)^{N-n}$

Mean = $N \cdot p$

Variance = $N \cdot p(1-p)$



However suppose $p \ll 1$, $N \gg 1$, and let $\lambda = N \cdot p$:

→ i.e. **very rare** process, but **very many trials** so still expect to see good events

Poisson distribution: $P(n; \lambda) = e^{-\lambda} \frac{\lambda^n}{n!}$

Mean = λ

Variance = $\lambda \Rightarrow$ **RMS = $\sqrt{\lambda}$**

$$(1-p)^{N-n} \stackrel{n \ll N}{\approx} \left(1 - \frac{\lambda}{N}\right)^N \stackrel{N \gg 1}{\approx} e^{-\lambda}$$

For n expected events, the uncertainty is \sqrt{n}

Rare processes ?

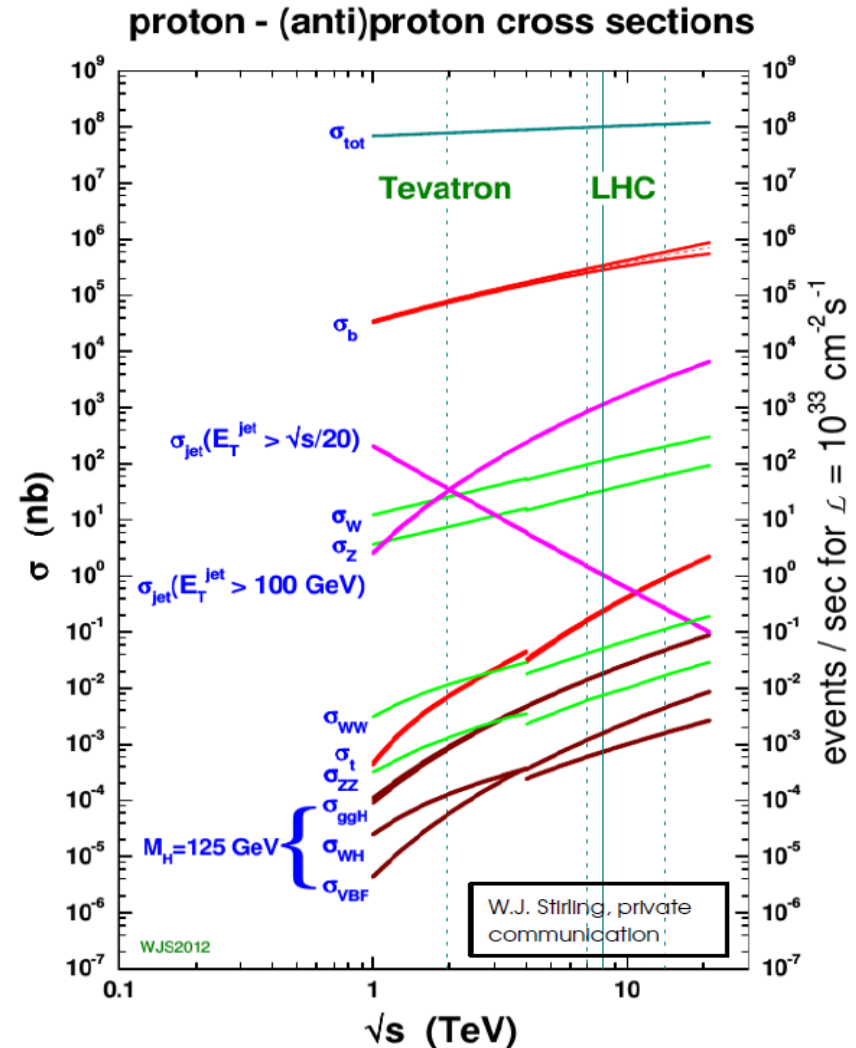
HEP : almost always use Poisson distributions. Why ?

ATLAS :

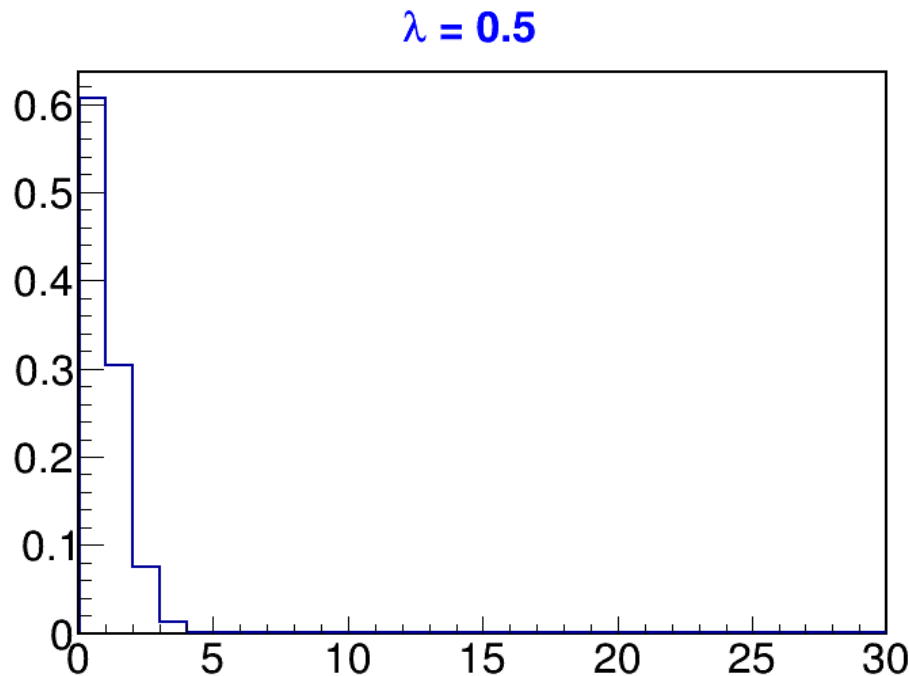
- **Event rate ~ 1 GHz**
($L \sim 10^{34} \text{ cm}^{-2}\text{s}^{-1} \sim 10 \text{ nb}^{-1}/\text{s}$, $\sigma_{\text{tot}} \sim 10^8 \text{ nb}$,)
 - **Trigger rate ~ 1 kHz**
(Higgs rate ~ **0.1 Hz**)
- $\Rightarrow p \sim 10^{-6} \ll 1$ ($p_{H \rightarrow \gamma\gamma} \sim 10^{-13}$)

A day of data: **$N \sim 10^{14} \gg 1$**
 \Rightarrow **Poisson regime!**

(Large N = design requirement, to get not-too-small $\lambda = Np \dots$)



Poisson distributions



$$P(\mathbf{n}; \lambda) = e^{-\lambda} \frac{\lambda^n}{n!}$$

λ : expected
number of events

$$\text{Mean} = \lambda$$

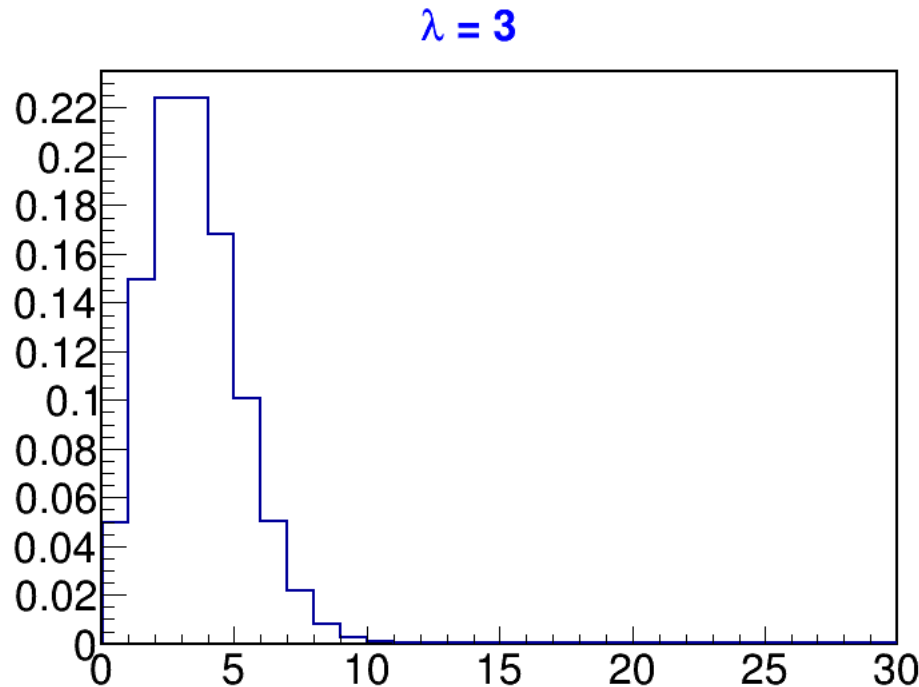
$$\text{Variance} = \lambda$$

$$\sigma = \sqrt{\lambda}$$

- **Discrete distribution** (positive integers only), **asymmetric** for small λ
- Typical variation (RMS) of n events is \sqrt{n}
- Central limit theorem : becomes **Gaussian** for large λ :

$$P(\lambda) \xrightarrow{\lambda \rightarrow \infty} G(\lambda, \sqrt{\lambda})$$

Poisson distributions



$$P(n; \lambda) = e^{-\lambda} \frac{\lambda^n}{n!}$$

λ : expected number of events

$$\text{Mean} = \lambda$$

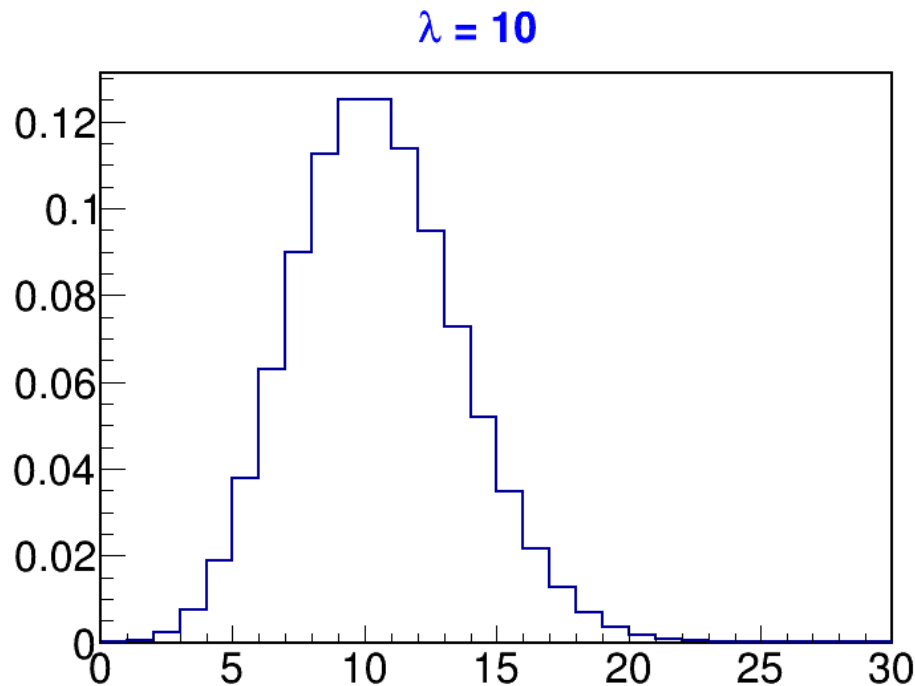
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Poisson distributions



$$P(\mathbf{n}; \lambda) = e^{-\lambda} \frac{\lambda^n}{n!}$$

λ : expected
number of events

$$\text{Mean} = \lambda$$

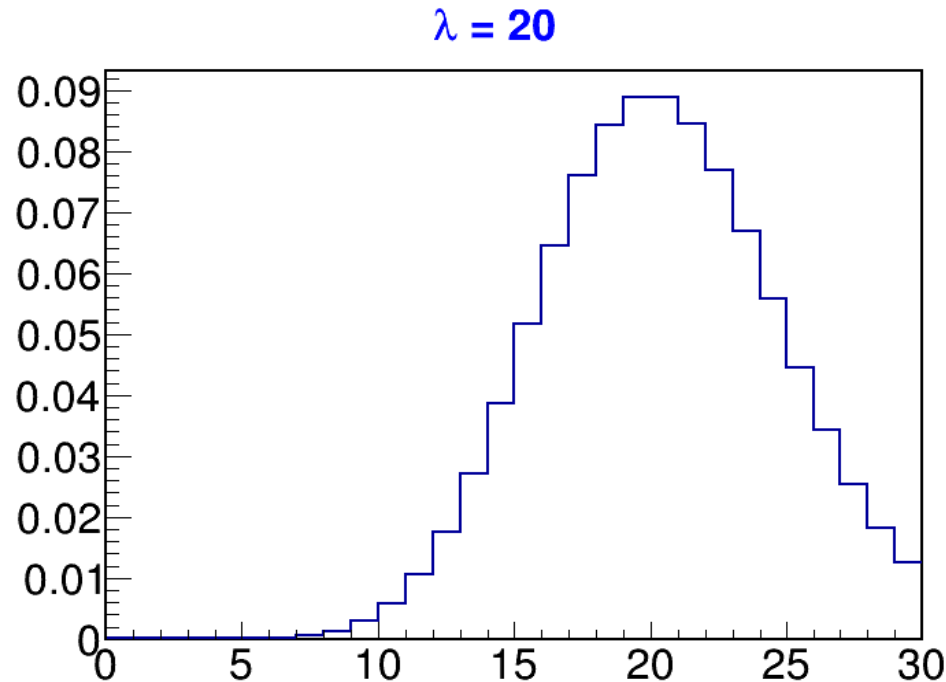
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$$\sigma = \sqrt{\lambda}$$

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$$P(\lambda) \xrightarrow{\lambda \rightarrow \infty} G(\lambda, \sqrt{\lambda})$$

Poisson distributions



$$P(\mathbf{n}; \lambda) = e^{-\lambda} \frac{\lambda^n}{n!}$$

λ : expected number of events

$$\text{Mean} = \lambda$$

$$\text{Variance} = \lambda$$

$$\sigma = \sqrt{\lambda}$$

- **Discrete distribution** (positive integers only), **asymmetric for small λ**
- Typical variation (RMS) of n events is \sqrt{n}
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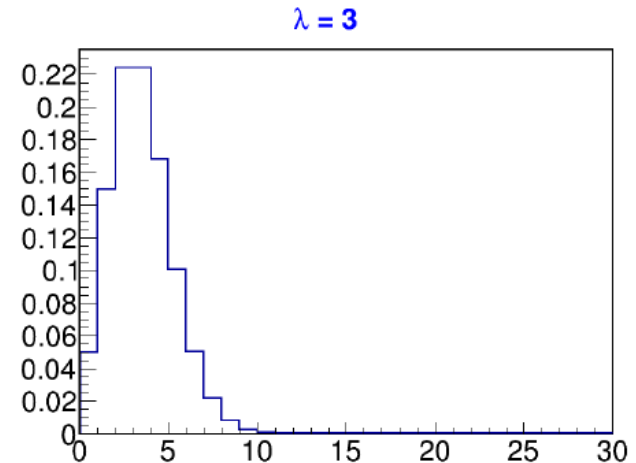
Statistical model for counting

Counting experiment:

Observable: number of events n

→ describe by a **Poisson distribution**

$$P(n; \lambda) = e^{-\lambda} \frac{\lambda^n}{n!}$$



Typically both signal and background expected:

$$P(n; S, B) = e^{-(S+B)} \frac{(S+B)^n}{n!}$$

S : # of events from signal process
 B : # of events from bkg. process(es)

We have **assumed** a Poisson distribution for n : This is our model, based on physics knowledge (but usually a very safe one).

Model has **parameters** S and B . B can be known a priori or not (S usually not...)

→ Example: can **assume** B is known, use the **measured** n to find out about the **parameter** S .

└ usually up to uncertainties → **systematics**

Z->ee inclusive σ^{fid}

Measurement Principle:

$$35000 \pm (\sqrt{35000} = 187)$$

$$\sigma^{\text{fid}} = \frac{n_{\text{data}} - N_{\text{bkg}}}{C_{\text{fid}} L}$$

- $n_{\text{data}} - N_{\text{bkg}}$ is 175 ± 8 (red arrow)

 - C_{fid} is 0.552 ± 0.006 (purple arrow)

 - L is $(81 \pm 2) \text{ pb}^{-1}$ (magenta arrow)

Signal events	$34865 \pm 187 \pm 7 \pm 3$
Correction C	$0.552^{+0.006}_{-0.005}$
σ^{fid} [nb]	$0.781 \pm 0.004 \pm 0.008 \pm 0.016$

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Simple uncertainty propagation:

$$\sigma^{\text{fid}} = 0.781 \pm 0.004 \text{ (stat)} \pm 0.008 \text{ (syst)} \pm 0.016 \text{ (lumi) nb}$$

Statistical uncertainty:
 Derived from assumption
 that n_{data} is $\sim \text{Poisson}(S+B)$

**Systematics: more on
 this in Lecture 3**

Unbinned shape analysis

Observable: set of values $m_1 \dots m_n$, one per event

→ Describe shape of the *distribution of m*

→ Deduce the **probability to observe $m_1 \dots m_n$**

H → $\gamma\gamma$ -inspired example:

- **Gaussian signal** $P_{\text{sig}}(m) = G(m; m_H, \sigma)$
- **Exponential bkg** $P_{\text{bkg}}(m) = \alpha e^{-\alpha m}$

⇒ Total PDF for a single event: Expected yields : S, B

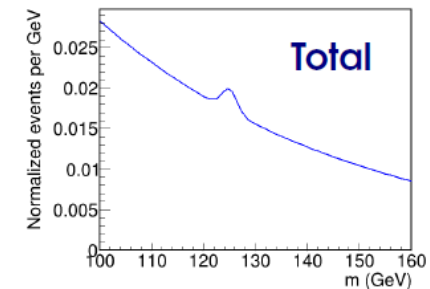
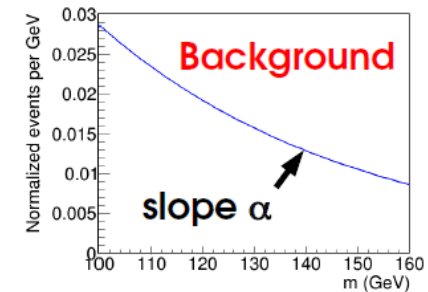
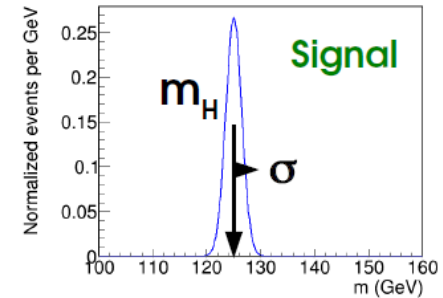
$$P_{\text{total}}(m) = \frac{S}{S+B} G(m; m_H, \sigma) + \frac{B}{S+B} \alpha e^{-\alpha m}$$

⇒ Total PDF for a dataset

Probability to observe n events

Probability to observe the value m_i

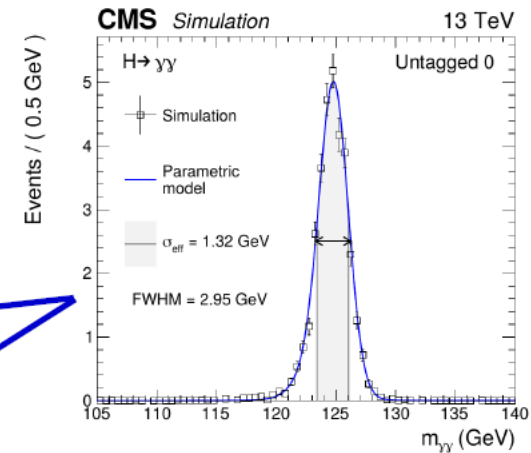
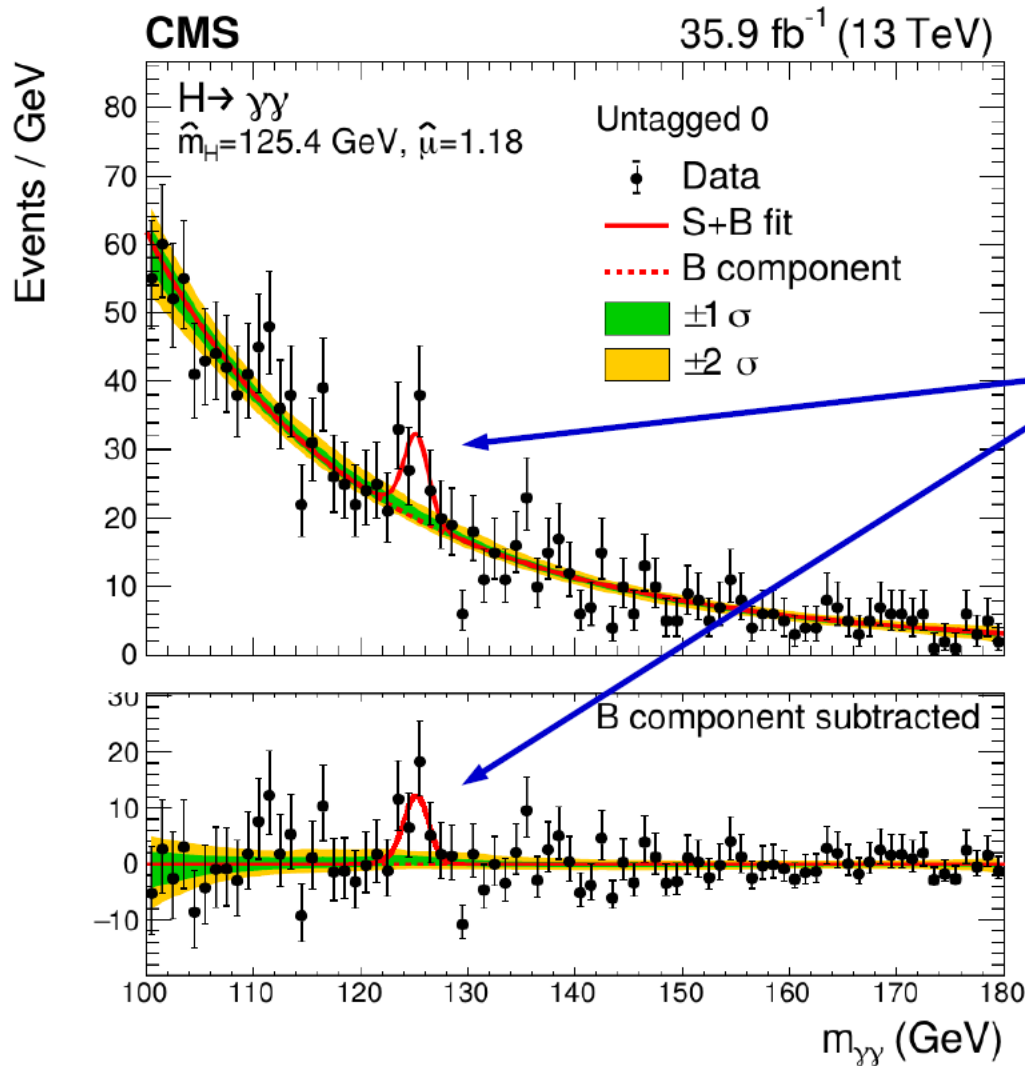
$$P(\{m_i\}_{i=1 \dots n}) = e^{-(S+B)} \frac{(S+B)^n}{n!} \prod_{i=1}^n \left[\frac{S}{S+B} G(m_i; m_H, \sigma) + \frac{B}{S+B} \alpha e^{-\alpha m_i} \right]$$



Unbinned shape analysis

$H \rightarrow \gamma\gamma$

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Binned shape analysis

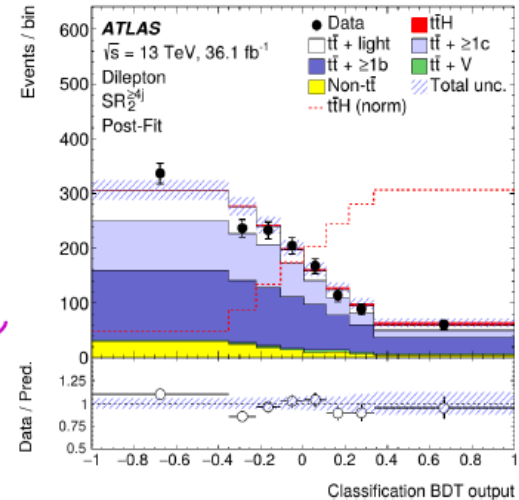
Instead of using $m_1 \dots m_n$ directly, can build a **histogram** $n_1 \dots n_N$.

→ N_{bins} : number of bins

Per-bin fractions (=shapes)
of Signal and Background

$$P(\{n_i\}; S, B) = \prod_{i=1}^{N_{\text{bins}}} e^{-(Sf_{S,i} + Bf_{B,i})} \frac{(Sf_{S,i} + Bf_{B,i})^{n_i}}{n_i!}$$

Poisson distribution in each bin



$N_{\text{bins}} = 1$: Counting analysis

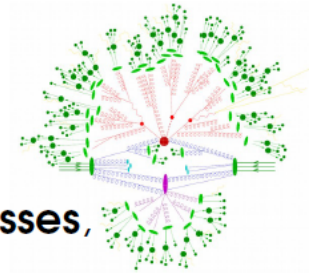
$N_{\text{bins}} \rightarrow \infty$: Unbinned shape analysis (the fractions become PDF values)

Shapes specified through $f_{S,i}, f_{B,i}$ rather than $P_{\text{signal}}(m), P_{\text{bkg}}(m)$

⊕ Obtained directly from MC, no need to define continuous PDFs.

⊖ MC stat fluctuations can create artefacts, especially for $S \ll B$.

How to describe data



Physics measurement data are produced through **random processes**,
Need to be described using a statistical model:

Description	Observable	Likelihood
Counting	n	Poisson $P(n; S, B) = e^{-(S+B)} \frac{(S+B)^n}{n!}$
Binned shape analysis	$n_i, i=1..N_{\text{bins}}$	Poisson product $P(\mathbf{n}_i; S, B) = \prod_{i=1}^{N_{\text{bins}}} e^{-(S f_i^{\text{sig}} + B f_i^{\text{bkg}})} \frac{(S f_i^{\text{sig}} + B f_i^{\text{bkg}})^{n_i}}{n_i!}$
Unbinned shape analysis	$m_i, i=1..n_{\text{evts}}$	Extended Unbinned Likelihood $P(\mathbf{m}_i; S, B) = \frac{e^{-(S+B)}}{n_{\text{evts}}!} \prod_{i=1}^{n_{\text{evts}}} S P_{\text{sig}}(m_i) + B P_{\text{bkg}}(m_i)$

Model can include multiple **categories**, each with a separate description